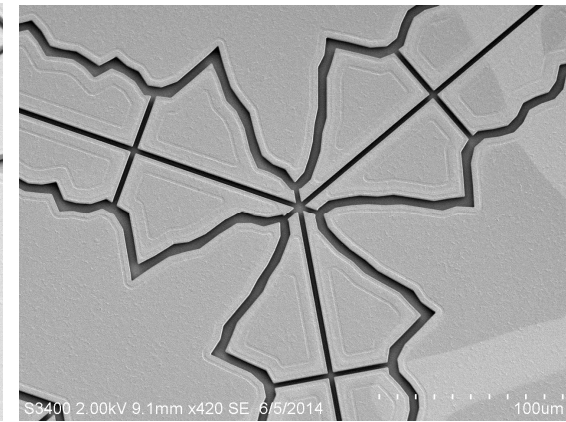
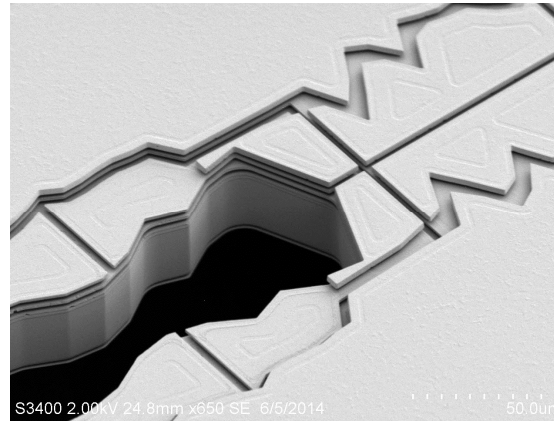
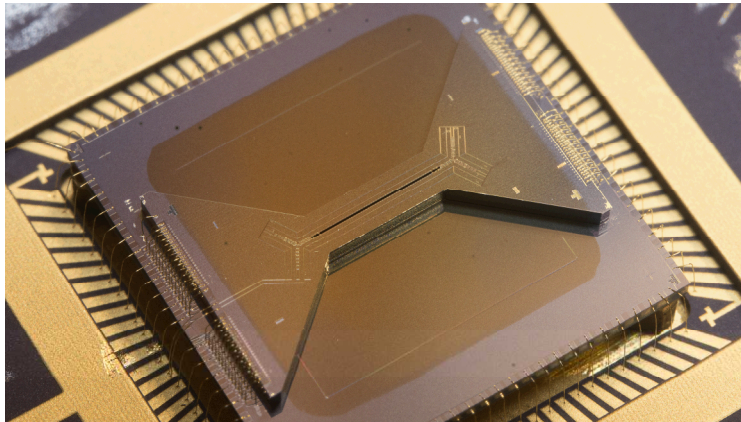


Exceptional service in the national interest



High-Fidelity Two-Qubit Quantum Gates in a Scalable Surface Ion Trap

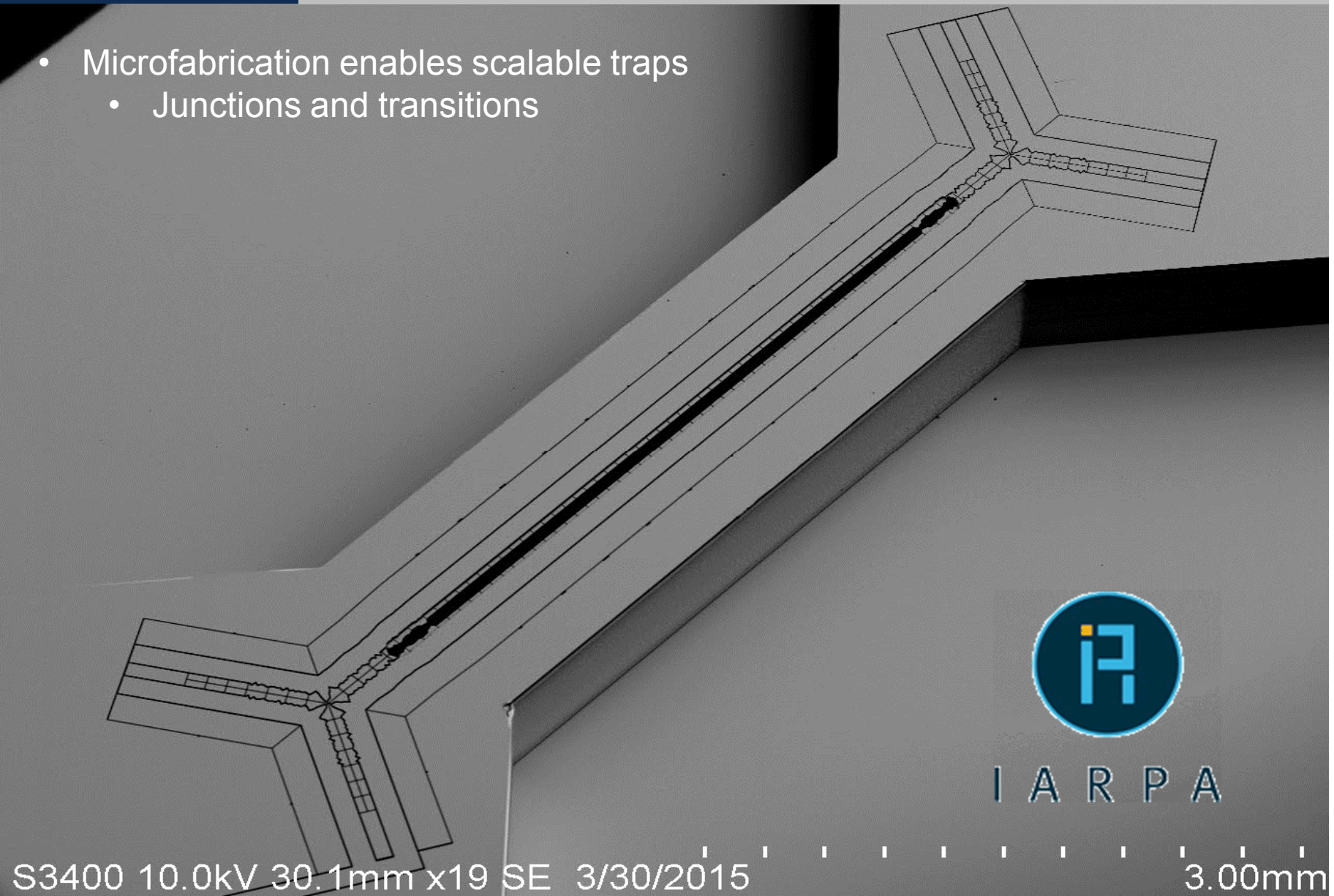


Peter Maunz
Sandia National Laboratories

Sandia National Laboratories is a multi-program laboratory managed and operated by Sandia Corporation, a wholly owned subsidiary of Lockheed Martin Corporation, for the U.S. Department of Energy's National Nuclear Security Administration under contract DE-AC04-94AL85000.

Micro-fabrication

- Microfabrication enables scalable traps
 - Junctions and transitions



Challenges of surface traps

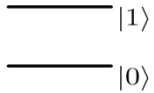
- Microfabrication enables scalable traps
 - Junctions and transitions
- Small distance to electrodes
 - Higher anomalous heating
- Nearby dielectrics
 - Possibly charging of the trap due to scattered laser light
- Small features
 - Sensitive to dust
- Higher anharmonic contributions to trap potential

Optimize traps for quantum information processing

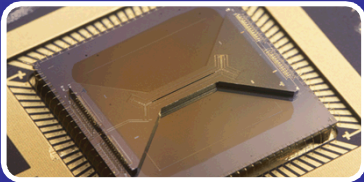
We will demonstrate that microfabricated surface traps can be used for high fidelity quantum operations



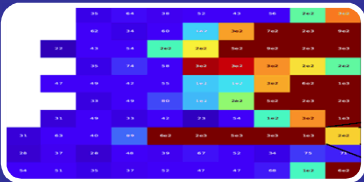
I Q P A



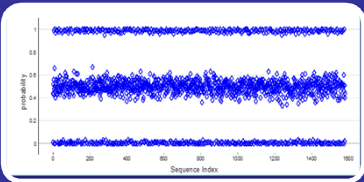
The ytterbium qubit



Sandia's HOA-2 trap

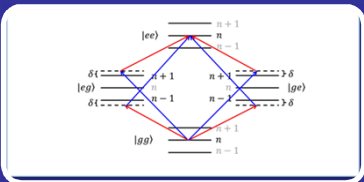


Characterization of quantum gates using GST
(Robin Blume-Kohout)



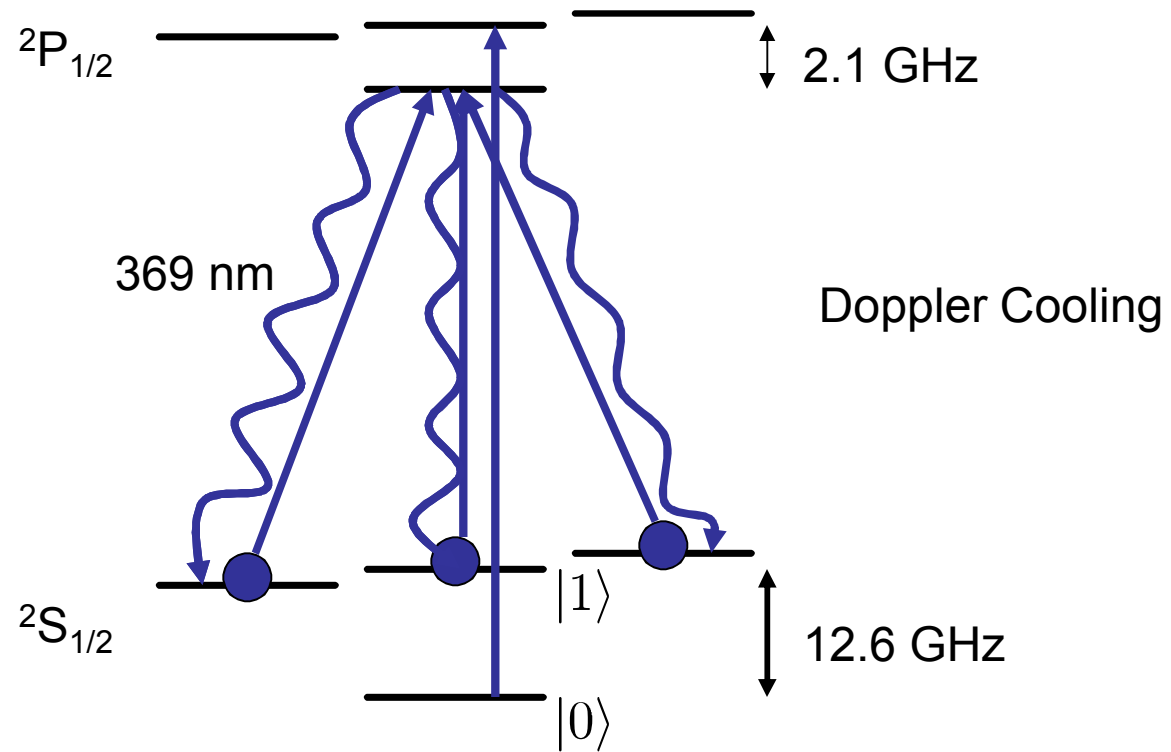
Single qubit gates

- Microwaves
- Raman transitions



Characterization of the Mølmer-Sørensen two-qubit gate

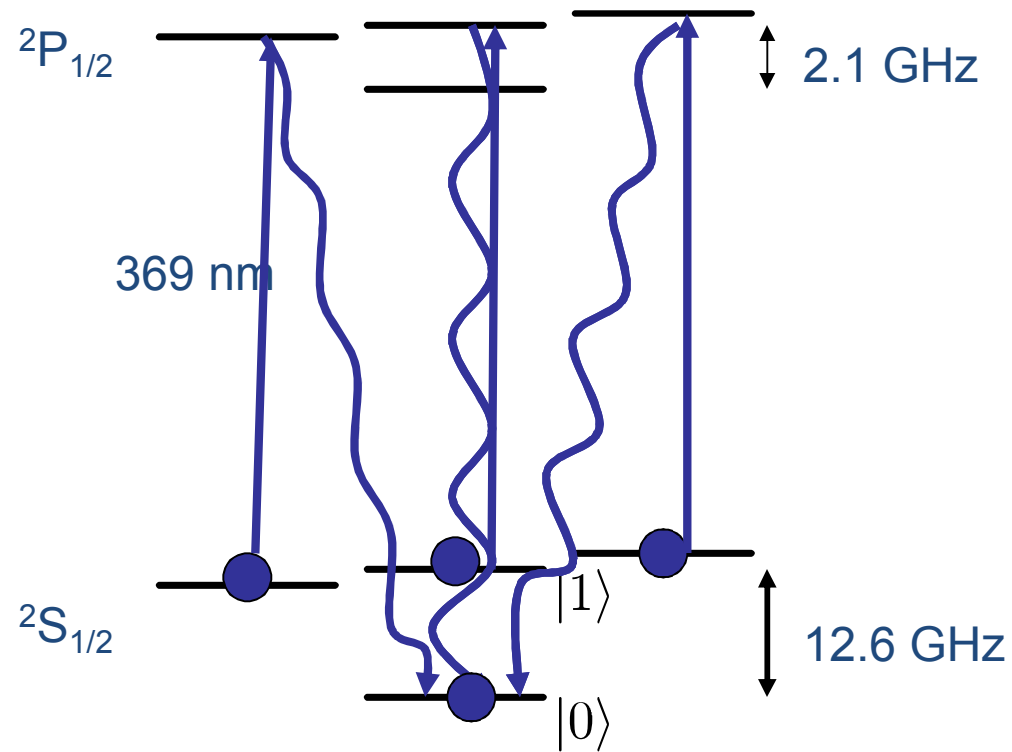
The Ytterbium Qubit



clock state qubit, magnetic field insensitive.

S. Olmschenk *et al.*, PRA **76**, 052314 (2007)

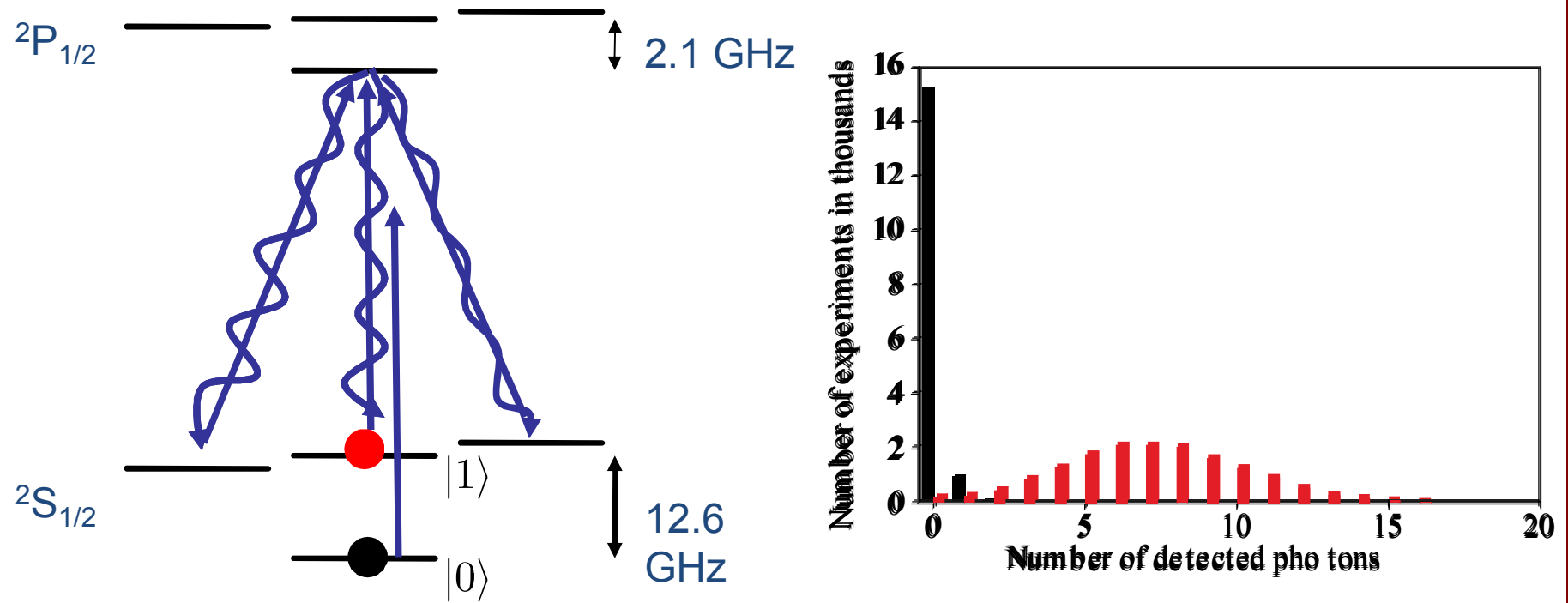
state initialization



clock state qubit, magnetic field insensitive.

S. Olmschenk *et al.*, PRA **76**, 052314 (2007)

$^{171}\text{Yb}^+$ state detection

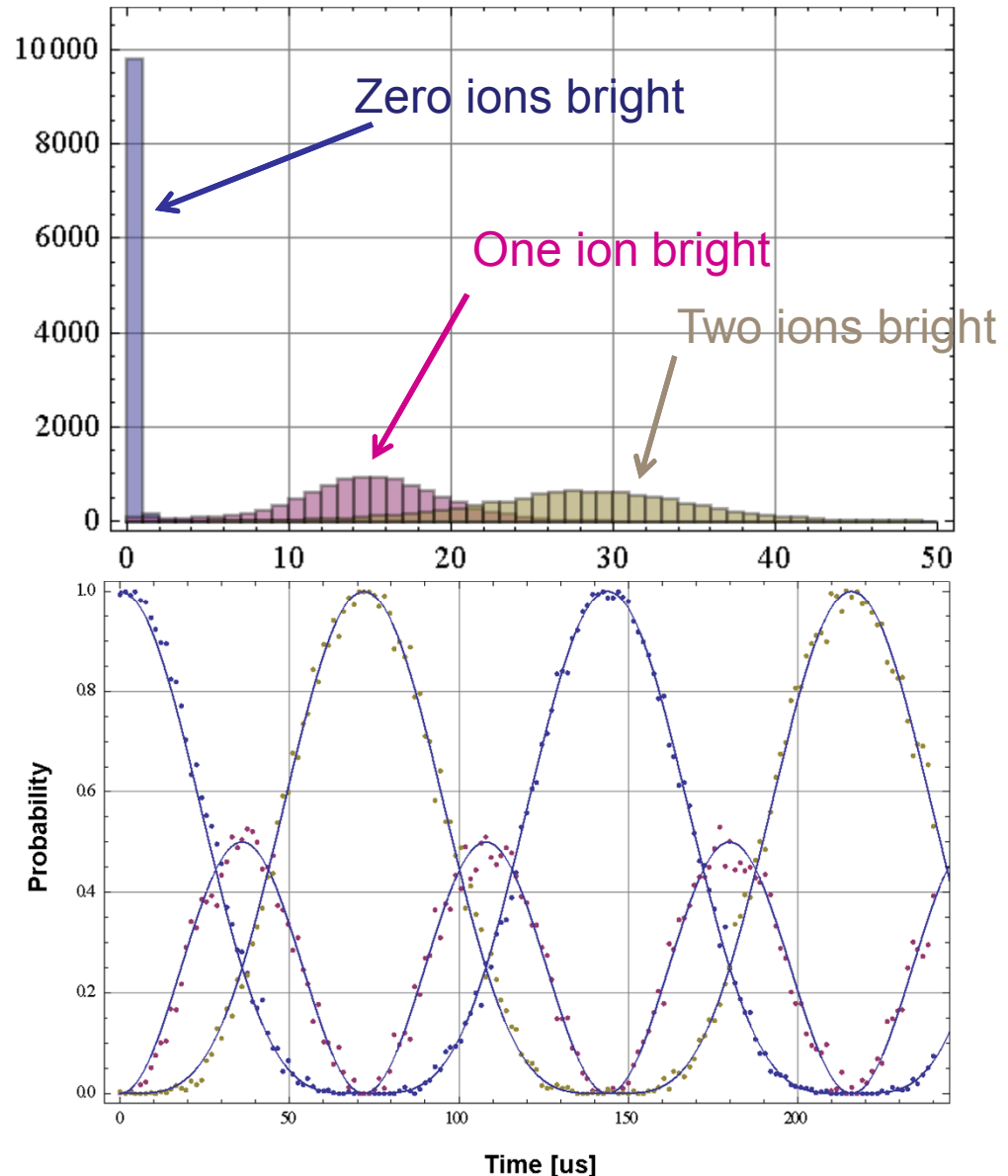


State detection for two ions

- Too much overlap between histograms of 1 and 2 bright ions
- Fit sums of experimentally measured 0, 1 and 2 ion bright histograms to determine probabilities of ensemble

Demonstration:

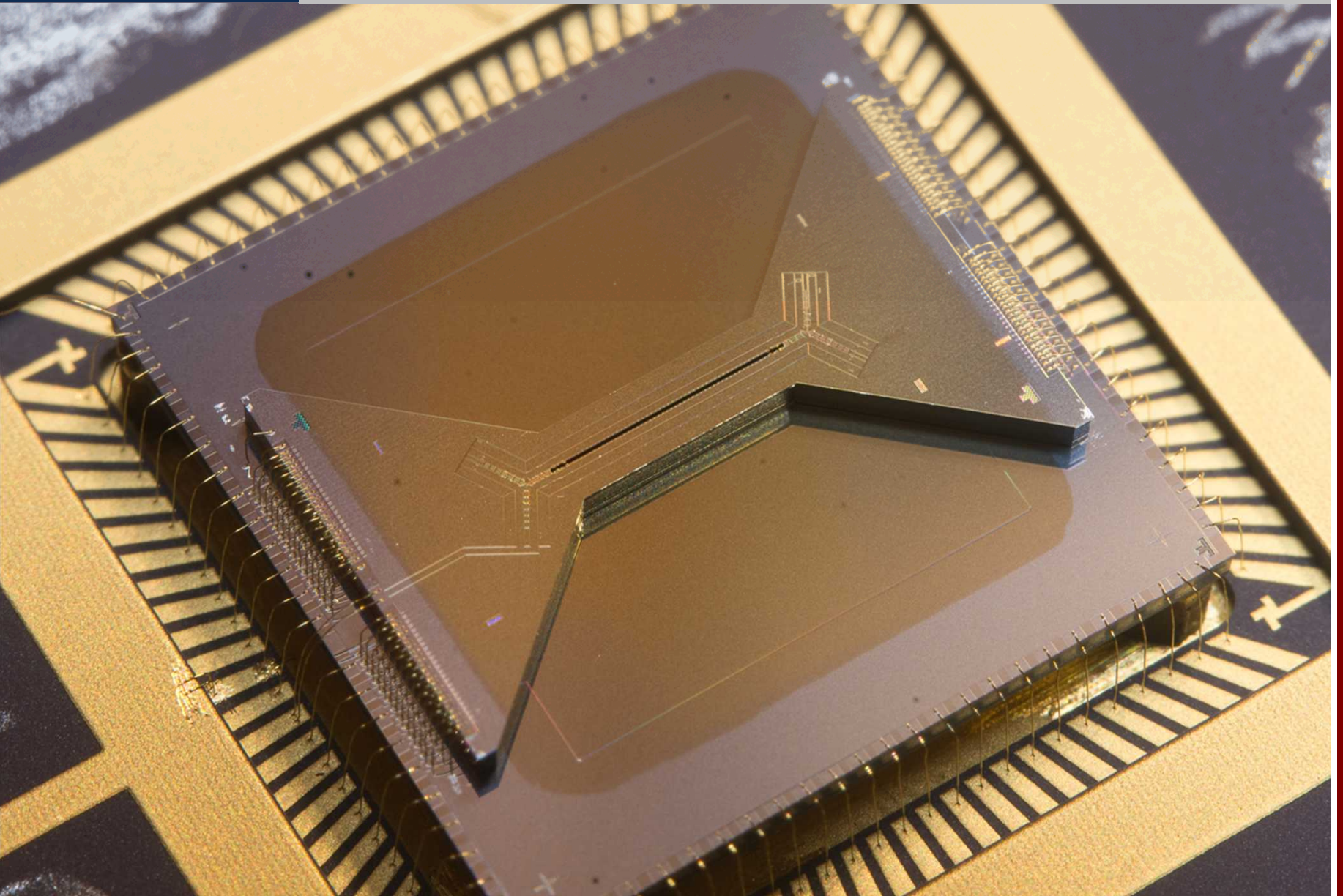
- Two trapped ions undergoing global Rabi oscillations
- Is described using one fit parameter: the π -time





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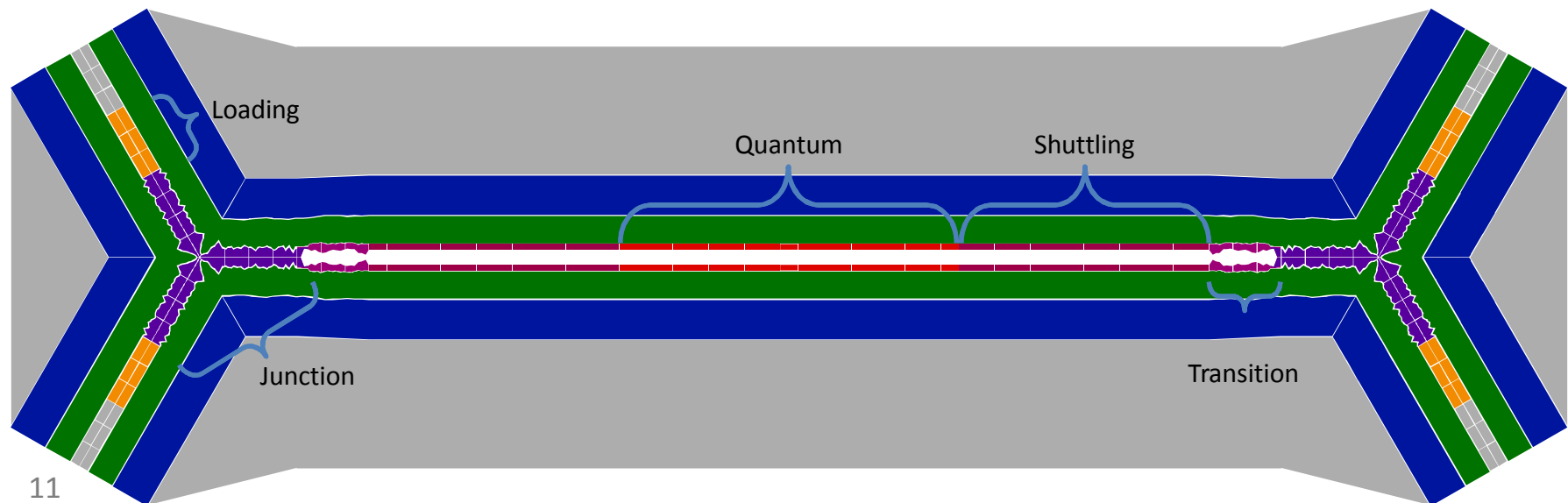
HOA-2 trap



High Optical Access trap

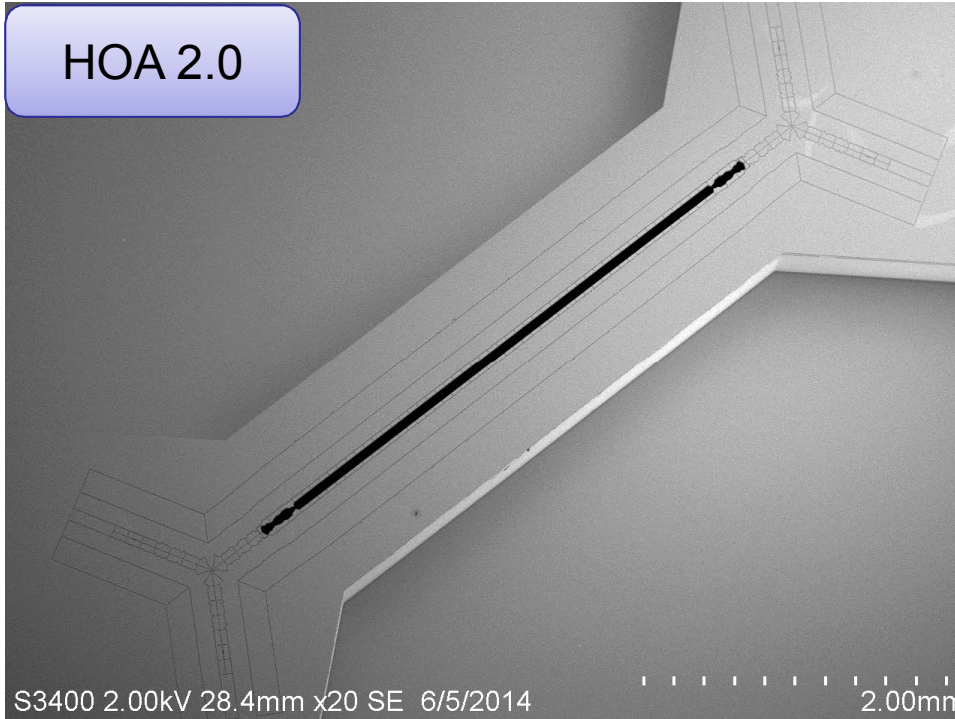
HOA-2

- Excellent optical access rivaling 3-D traps (NA 0.25 vertical, NA 0.12 lateral)
- High trap frequencies (small characteristic distance 140 μm , closest electrode 90 μm from ions)
- Full control over principal axes rotation (0 - 40 degree)
- Excellent axial control using segmented inner electrodes
 - Tighter and smaller axial trap
 - Much better separation and recombination of chains
- Small resistance between electrode and bondpad (<4 Ω)
- Made possible by process improvements and optimizations

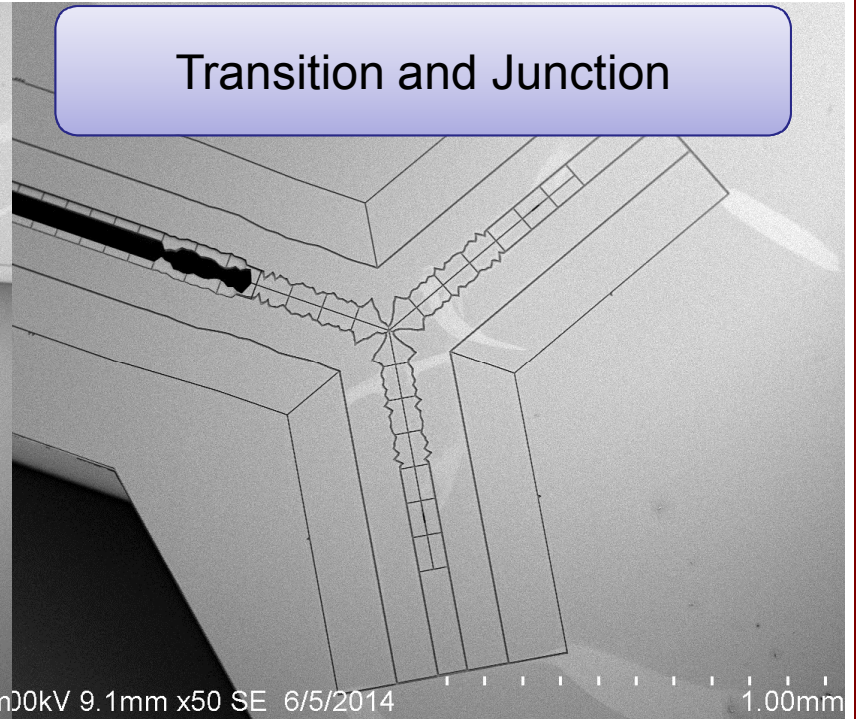


Trap details

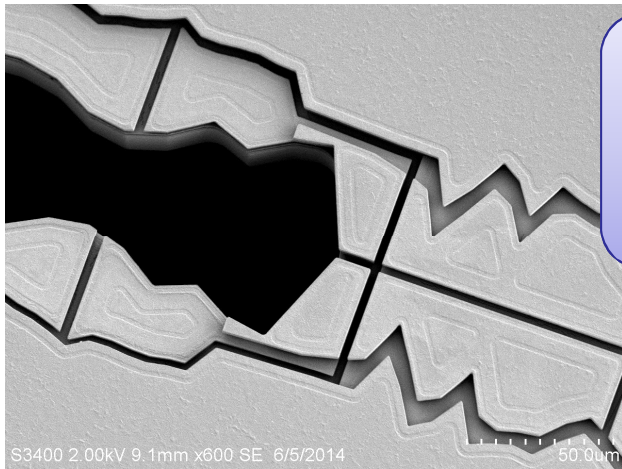
HOA 2.0



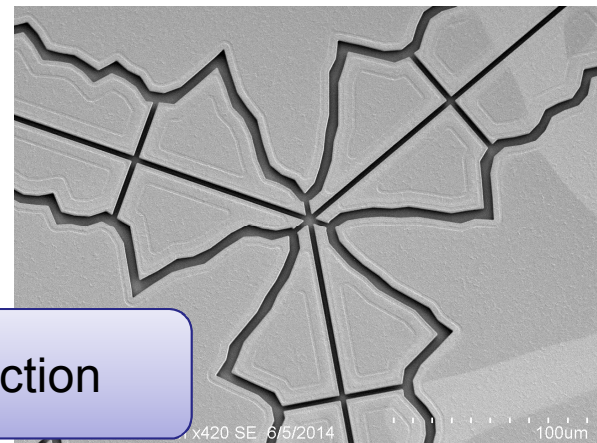
Transition and Junction



Vertical distance
12 μm



Junction



HOA-2 trap characteristics

A high-magnification micrograph of a microchip used for ion trapping. The chip is a dark, rectangular substrate with a complex pattern of gold-colored electrodes and wiring. A central, Y-shaped electrode structure is prominent. The chip is mounted on a larger, gold-colored carrier with a grid of contact points.

Ytterbium

Trap frequencies:

- radial 2.7 MHz
- rf frequency 50 MHz
- stable for two ions

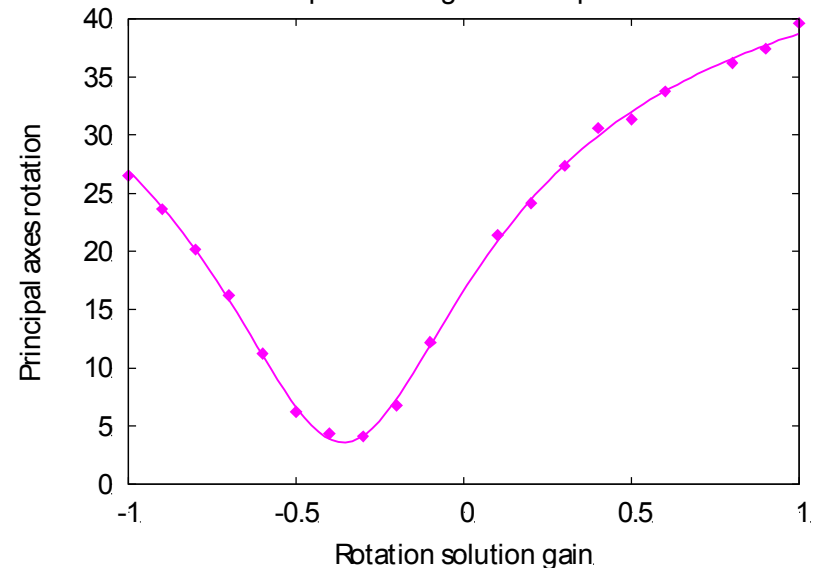
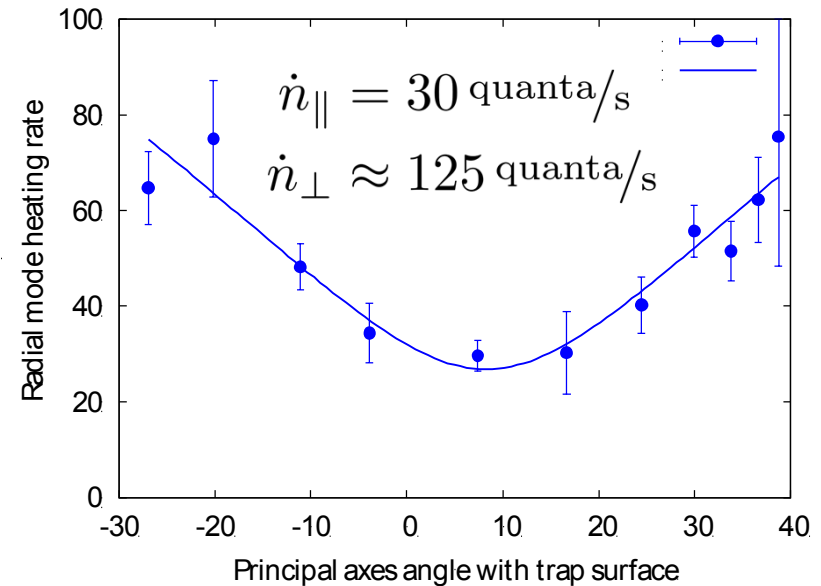
Trapping time:

- >100 h observed
(while running measurements)
- >5 min without cooling

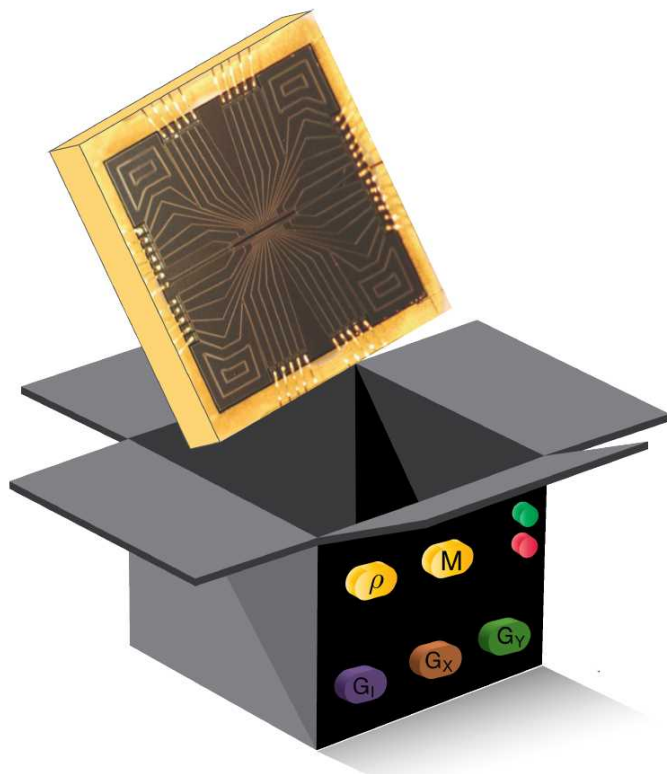
Heating rates as function of principal axes rotation

- Principal axes rotation measured by measuring π -times of Rabi flopping on cooled motional modes
- Minimal heating rates for motional mode parallel to trap surface \dot{n}_{\parallel}
- Without technical noise: Vertical mode has at most $\dot{n}_{\perp} \leq 2\dot{n}_{\parallel}$
(P. Schindler, et al., Phys. Rev. A **92**, 013414 (2015)).
- Limited by technical noise

$^{171}\text{Yb}^+$, Trap frequency 2.8 MHz, r.f. 50 MHz



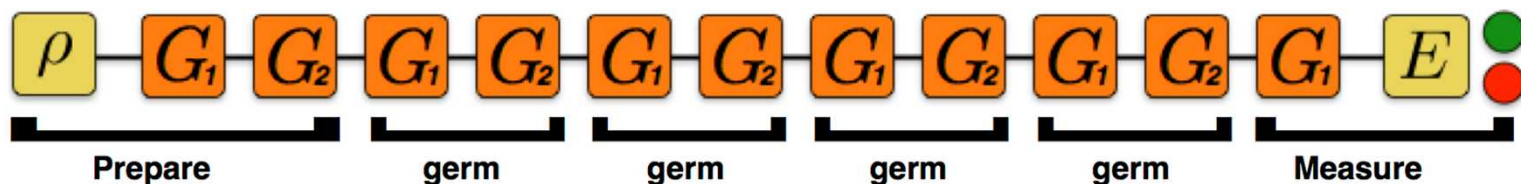
Gate Set Tomography



Developed at Sandia by
Robin Blume-Kohout et al. (1425)

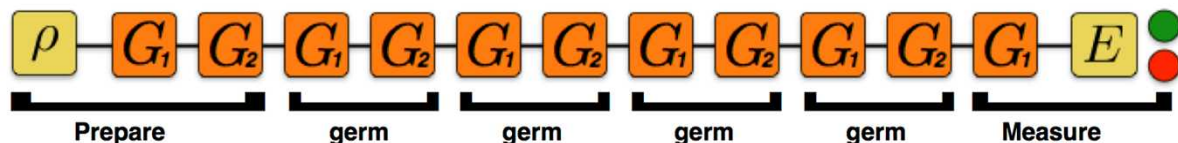
- No calibration required
- Detailed debug information
- Efficiently measures performance characterizing fault-tolerance (diamond norm)
- Detects non-Markovian noise

Uses structured sequences to amplify all possible errors



GST Experiments

Single qubit BB1 compensated microwave gates on $^{171}\text{Yb}^+$



Desired “target” gates:

G_i Idle (Identity)

G_x $\pi/2$ rotation about x -axis

G_y $\pi/2$ rotation about y -axis

Fiducials:

$\{\}$

G_x

G_y

$G_x \cdot G_x$

$G_x \cdot G_x \cdot G_x$

$G_y \cdot G_y \cdot G_y$

Germs:

G_x

G_y

G_i

$G_x \cdot G_y$

$G_x \cdot G_y \cdot G_i$

$G_x \cdot G_i \cdot G_y$

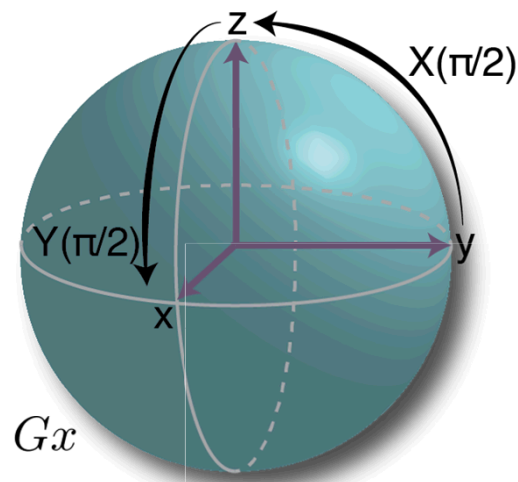
$G_x \cdot G_i \cdot G_i$

$G_y \cdot G_i \cdot G_i$

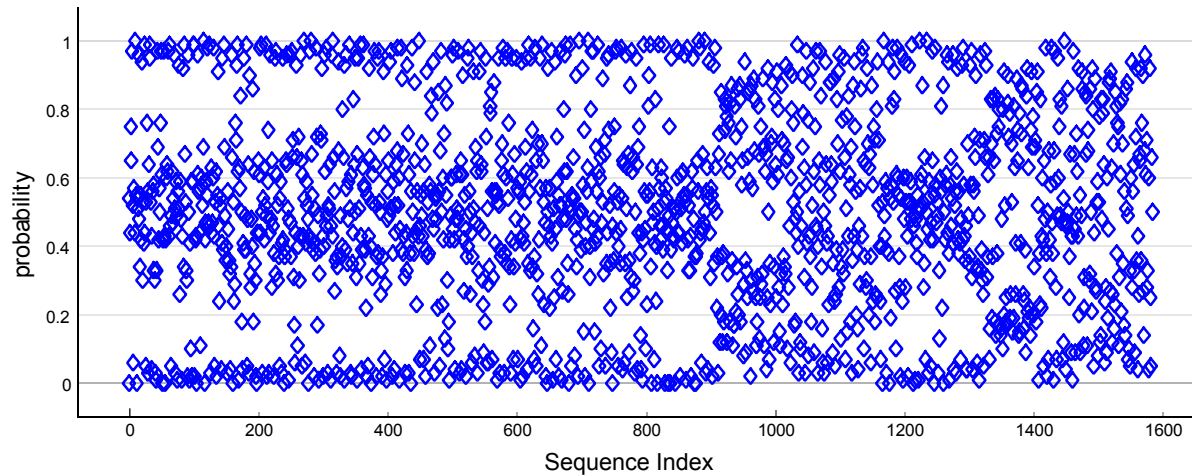
$G_x \cdot G_x \cdot G_i \cdot G_y$

$G_x \cdot G_y \cdot G_y \cdot G_i$

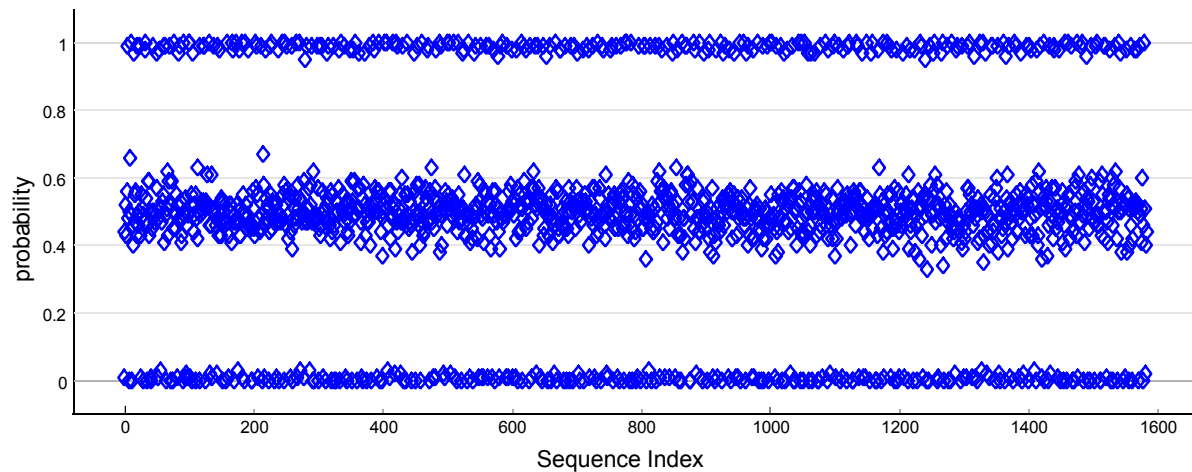
$G_x \cdot G_x \cdot G_y \cdot G_x \cdot G_y \cdot G_y$



Raw data poor gates

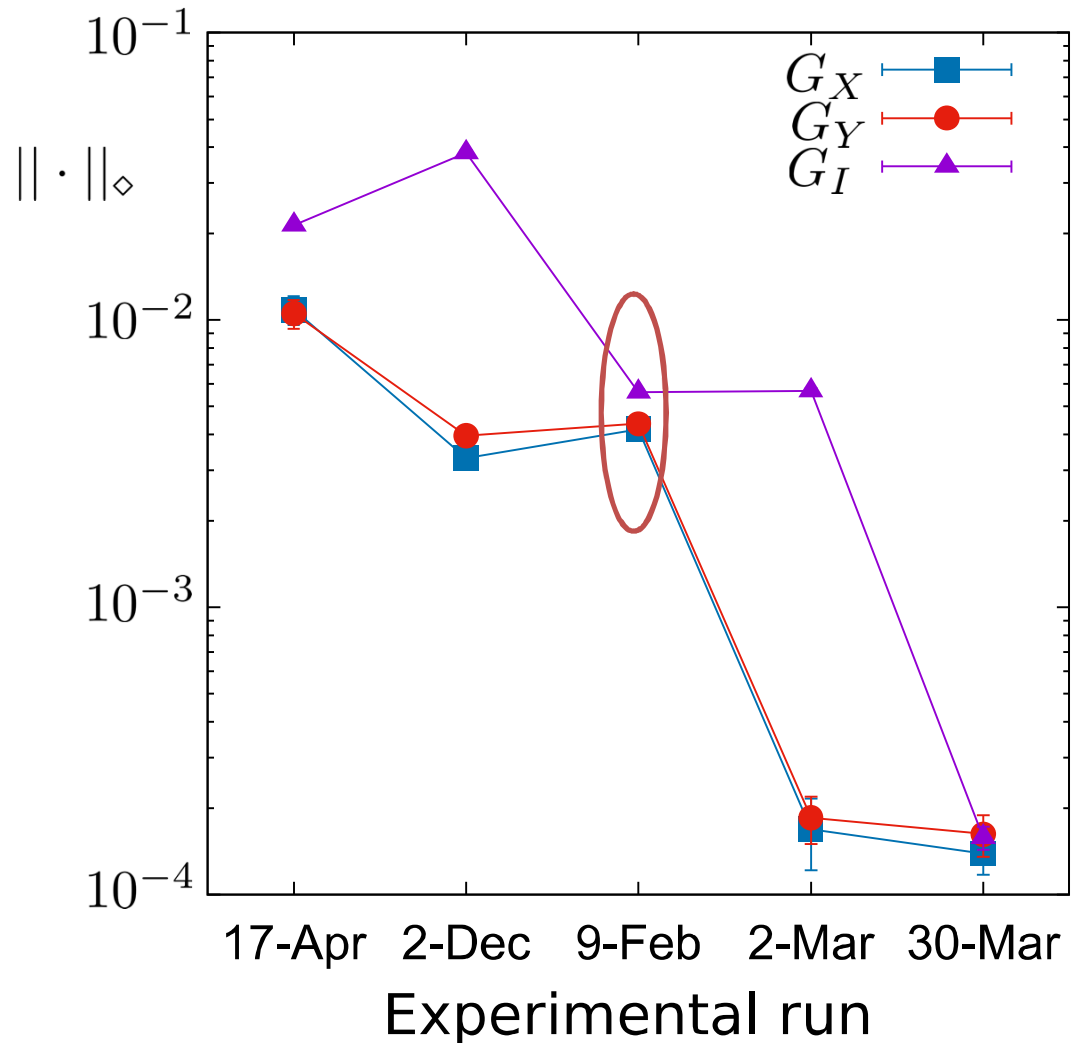


Raw data good gates



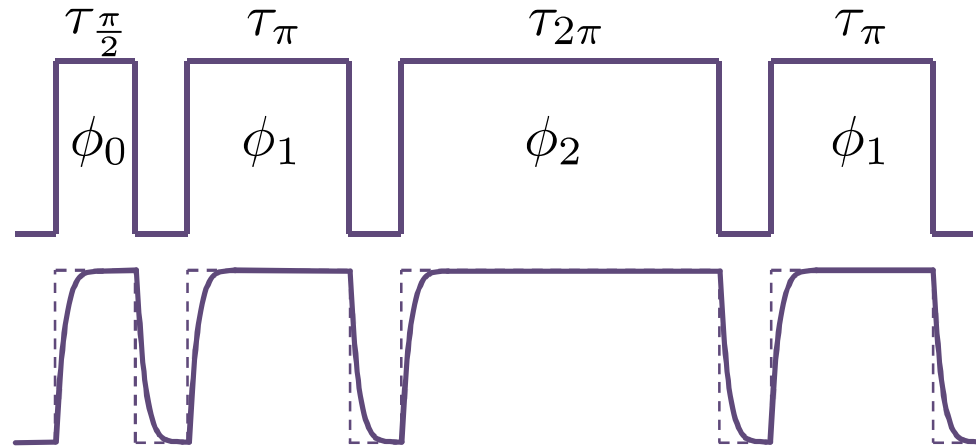
GST: debugging microwave gates

Gate	Rotn. axis	Angle
G_I	0.5252 -0.009 0.8506 -0.0244	0.001699π
G_X	-3×10^{-6} -1 -3×10^{-5} -0.009	0.501308π
G_Y	-0.2474 0.0001 0.9689 -0.0001	0.501366π



Broadband pulses

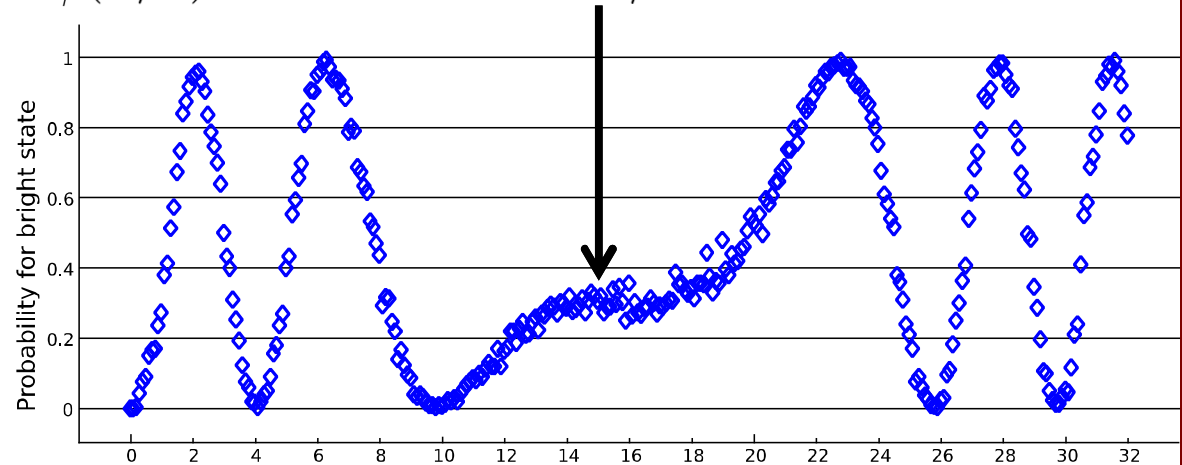
BB1 compensated pulse



Switching artifacts

$$R_{\phi}(\pi/2)^9$$

Correct $\pi/2$ time

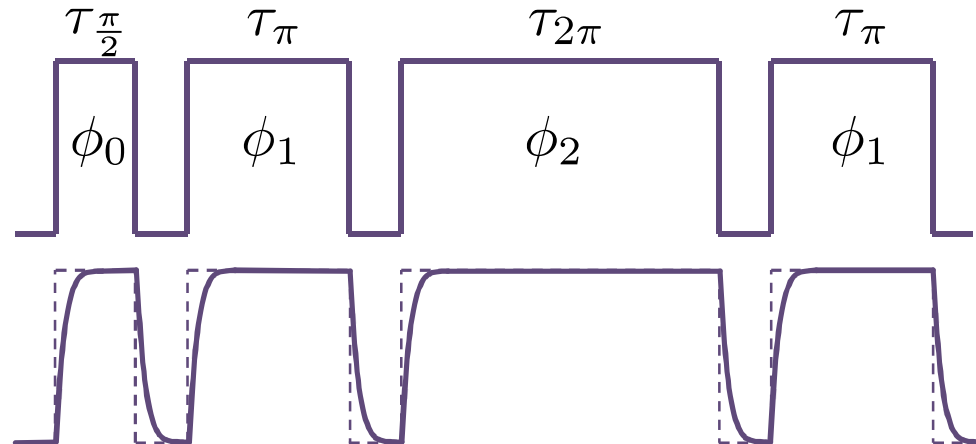


Example:

- Derivative vanishes at correct time
- However: Probability is *not* 50% as expected

Broadband pulses

BB1 compensated pulse

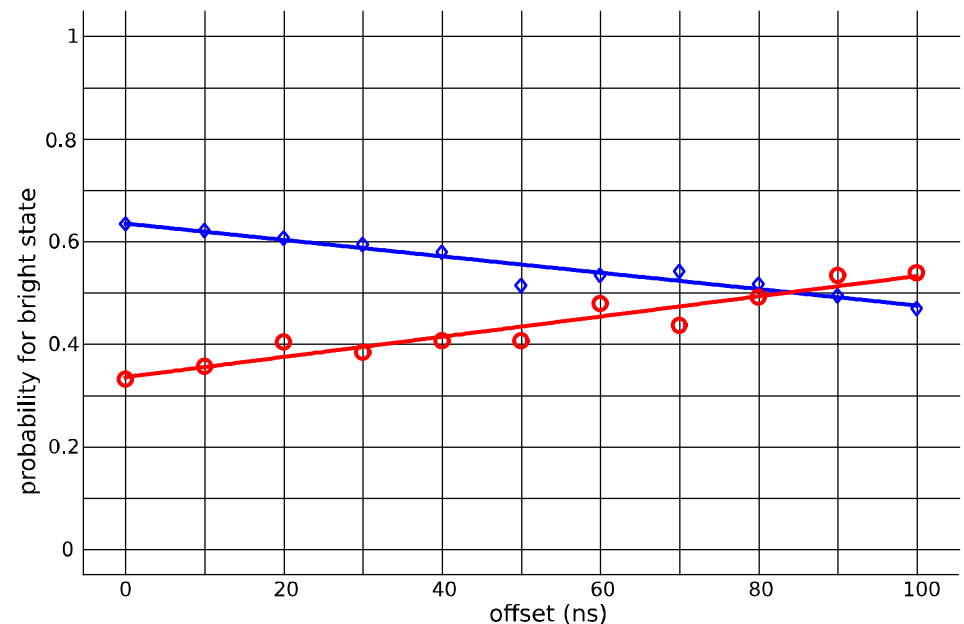


Switching artefacts

Calibration of offset time added to each pulse

$$R_{\phi}(\pi/2)^{101}$$

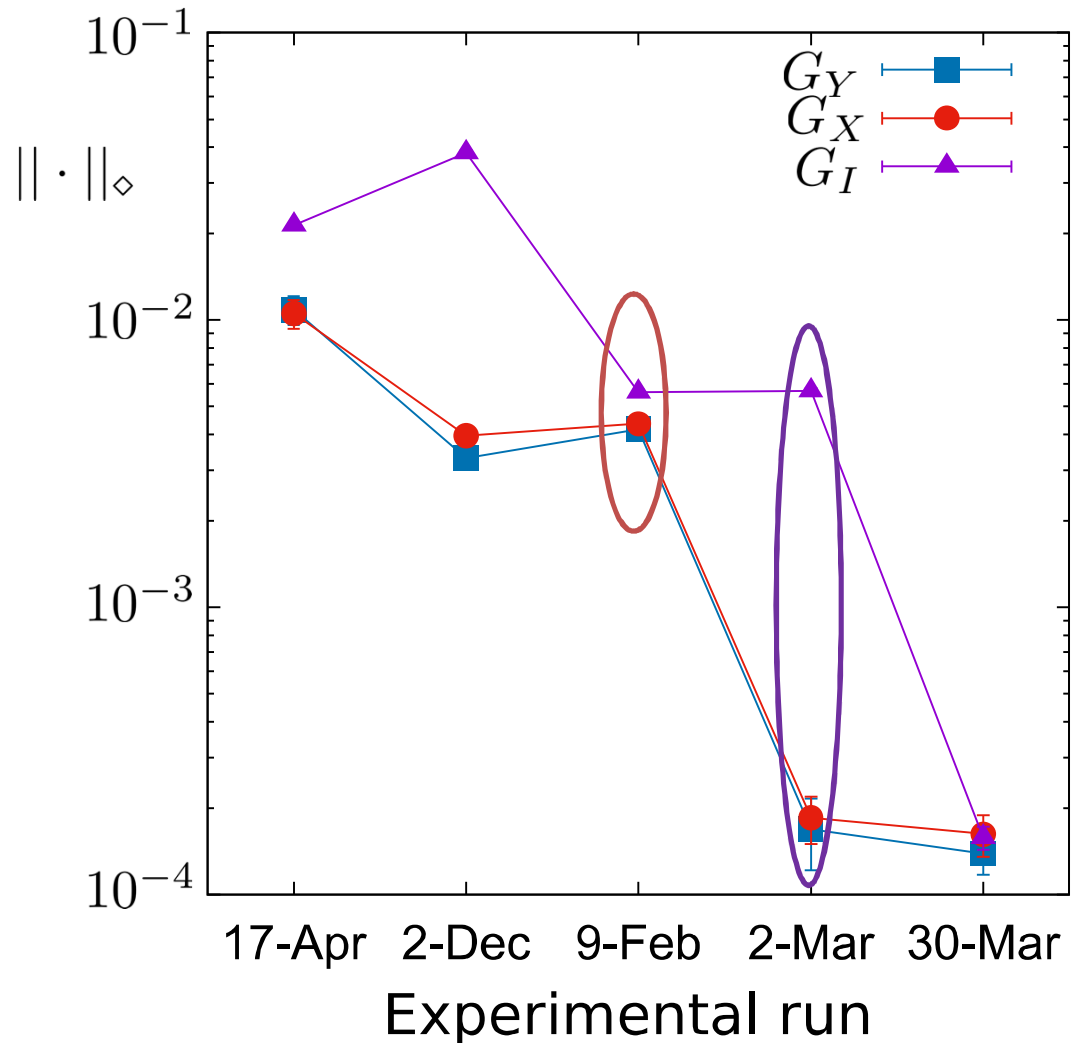
$$R_{\phi}(\pi/2)^{103}$$



GST: debugging microwave gates

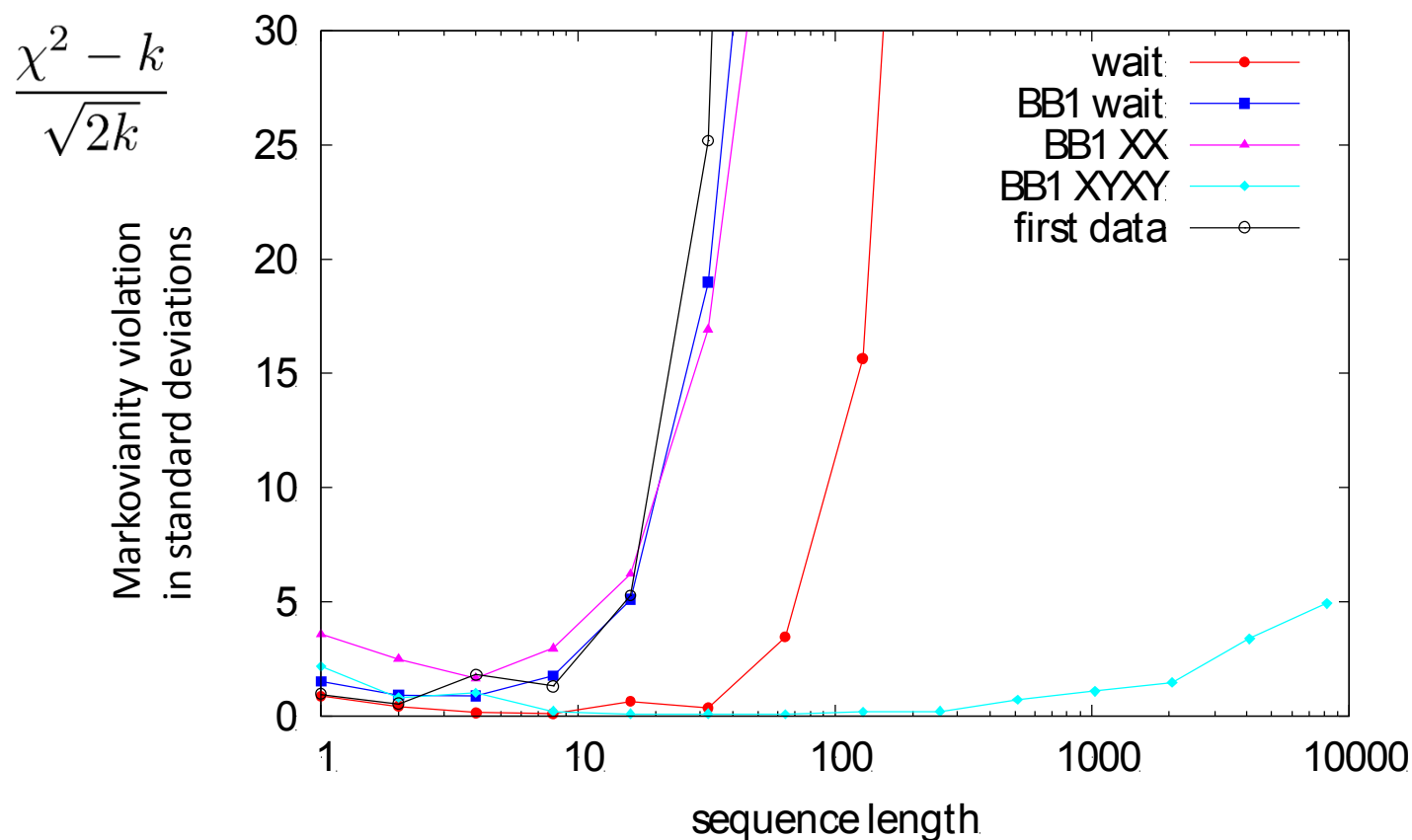
Gate	Rotn. axis	Angle
G_I	0.5252	0.001699π
	-0.009	
	0.8506	
	-0.0244	
G_X	-3×10^{-6}	0.501308π
	-1	
	-3×10^{-5}	
	-0.009	
G_Y	-0.2474	0.501366π
	0.0001	
	0.9689	
	-0.0001	

Gate	Rotn. axis	Angle
G_I	-0.0035	0.001769π
	0.014	
	-0.9999	
	0.0006	
G_X	-3×10^{-5}	0.500007π
	-1	
	1×10^{-4}	
	0.0006	
G_Y	0.1104	0.50001π
	4×10^{-5}	
	0.9939	
	0.0005	



GST Markovianity violation microwave gates

The χ^2 values from the fits are expected to follow a χ^2 distribution with mean k and standard deviation $\sqrt{2k}$



BB1 decoupled gates with decoupled identity have very small non-Markovian noise

GST: Microwave results

Best results for microwave single qubit gates:

- BB1 dynamically compensated pulse sequences
- Decoupling sequence for identity gate
- Drift control for π -time and qubit frequency

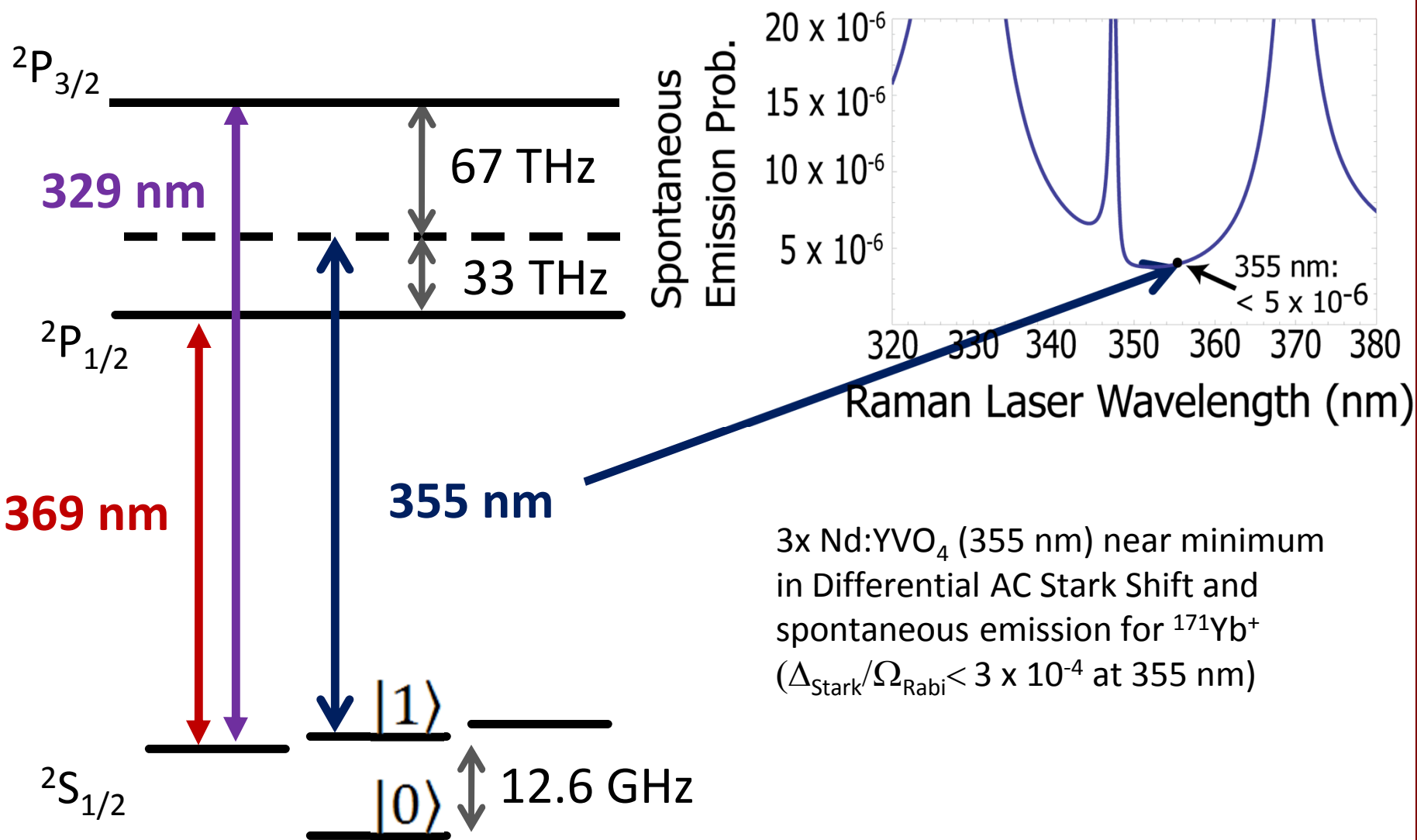
95% confidence intervals

Gate	Process Infidelity	$1/2 \diamond$ -Norm
G_I	$6.9(6) \times 10^{-5}$	$7.9(7) \times 10^{-5}$
G_X	$6.1(7) \times 10^{-5}$	$7.0(15) \times 10^{-5}$
G_Y	$7.2(7) \times 10^{-5}$	$8.1(15) \times 10^{-5}$

All gates are better than the fault tolerance threshold of 9.7×10^{-5}
P. Aliferis and A. W. Cross, Phys. Rev. Lett. 98, 220502 (2007).

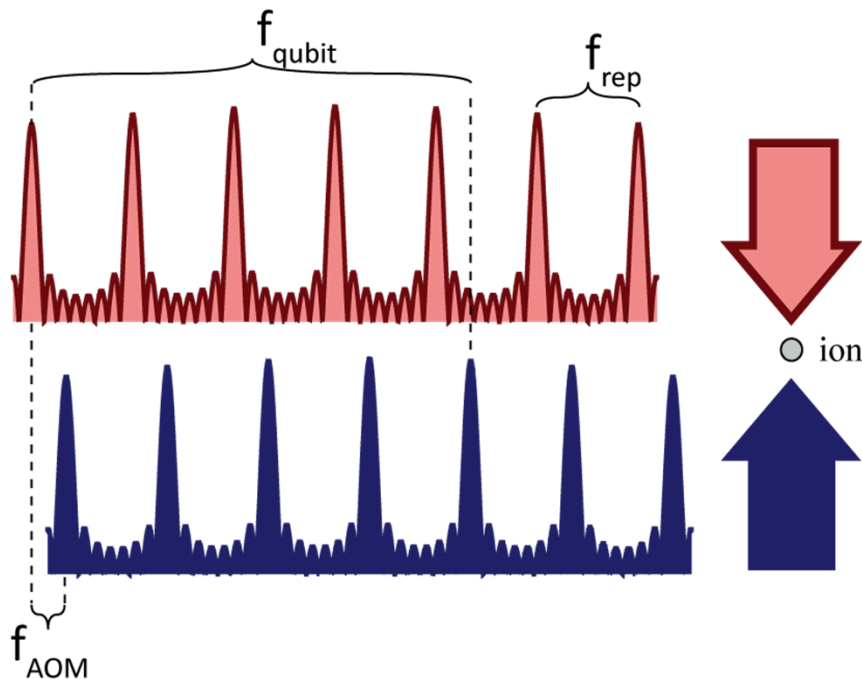
- Time resolution:
 - Current time resolution is 5 ns
 - π -times are 45 μ s
 - ratio: 10^{-4}
 - Possible due to broadband pulses
- Coherence time:
 - $T_2^* = 1$ s
 - longest pulse sequences 8192 : 1.66 s

355 Raman transitions: $^{171}\text{Yb}^+$



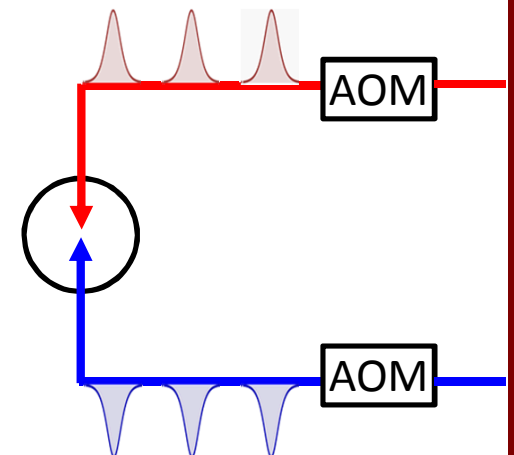
Pulsed laser Raman transitions

- Couple to ions using 355nm frequency comb
- Beat note created by repetition rate and AOM shift
- Get large splitting for free

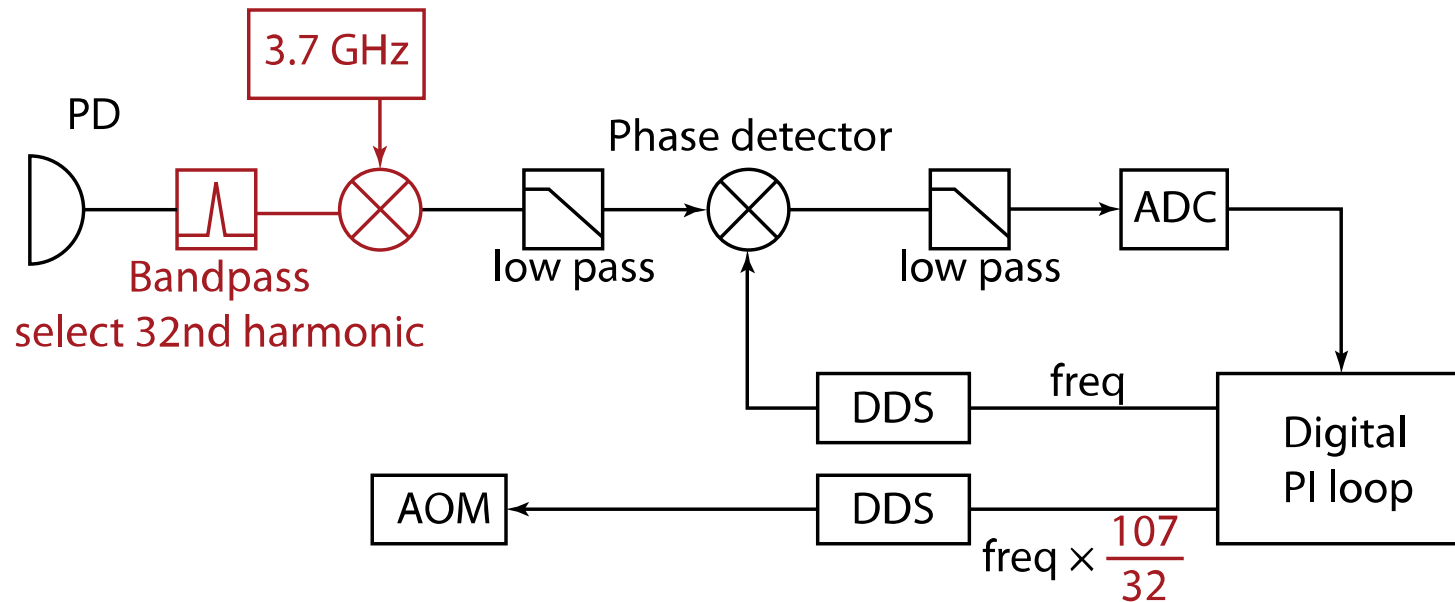


Requirement:

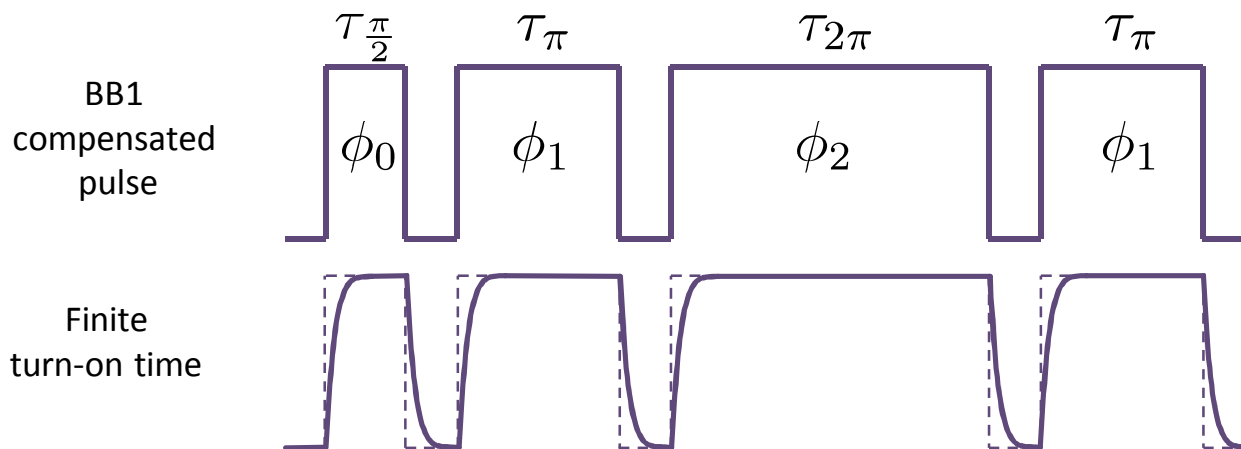
$$f_{\text{qubit}} = n f_{\text{rep}} \pm f_{\text{AOM}}$$



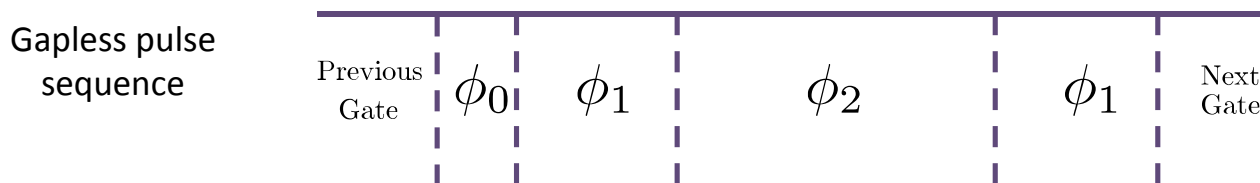
Stabilizing the beatnote frequency



“Gapless” Pulse Technique



BB1 compensation assumes variations in pulse area are scaled proportionally for extra compensation pulses. Finite turn on-time effects are independent of pulse length and do not scale! Power stabilization of Raman beams is limited by ADC readout times in feedback loop.



Discontinuous phase updates are used in place of gaps. Solves issues related to finite turn-on time and allows for continuous feedback on the driving field power.

GST: Raman laser results



co-propagating beam geometry

- Motion independent
- No optical phase imprinted

- BB1 dynamically compensated pulse sequences

GST results:

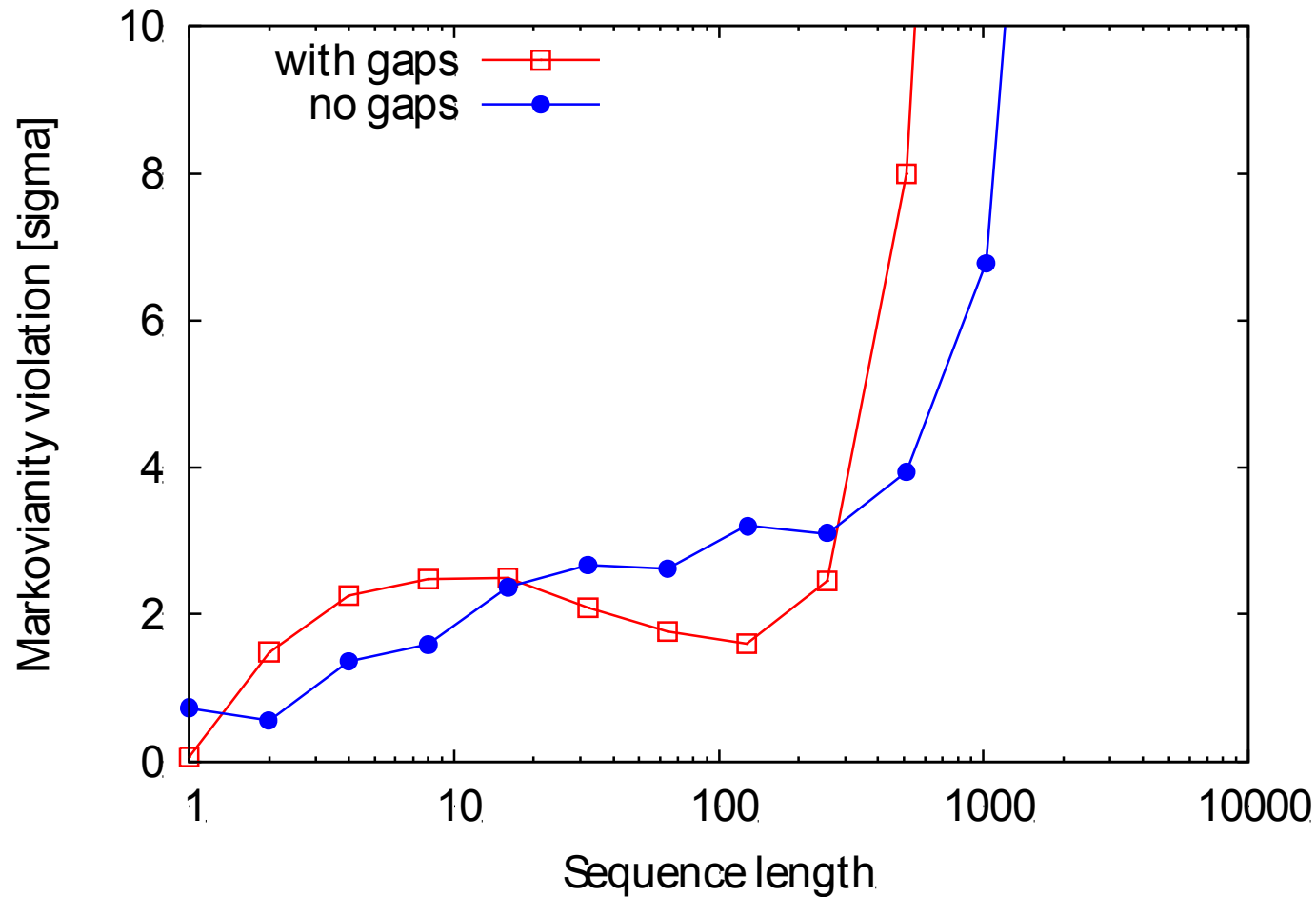
95% confidence intervals

Gate	Conventional pulses		Gapless pulses	
	Process Infidelity	$1/2 \diamond$ -Norm	Process Infidelity	$1/2 \diamond$ -Norm
G_I	$0.05(2) \times 10^{-4}$	$12(1) \times 10^{-4}$	$1.1(1) \times 10^{-4}$	$5.3(2) \times 10^{-4}$
G_X	$1.3(1) \times 10^{-4}$	$4(2) \times 10^{-4}$	$0.5(1) \times 10^{-4}$	$2(6) \times 10^{-4}$
G_Y	$1.6(4) \times 10^{-4}$	$4(3) \times 10^{-4}$	$0.7(1) \times 10^{-4}$	$4(9) \times 10^{-4}$

Process Infidelity $< 1.2 \times 10^{-4}$
 $1/2 \diamond$ -Norm $< 5.5 \times 10^{-4}$

Markovianity violation

Gapless versus standard pulses



GST: Raman laser results



counter-propagating beam geometry

- Motion can be addressed
- Imprints an optical phase on the qubit

- BB1 dynamically compensated pulse sequences

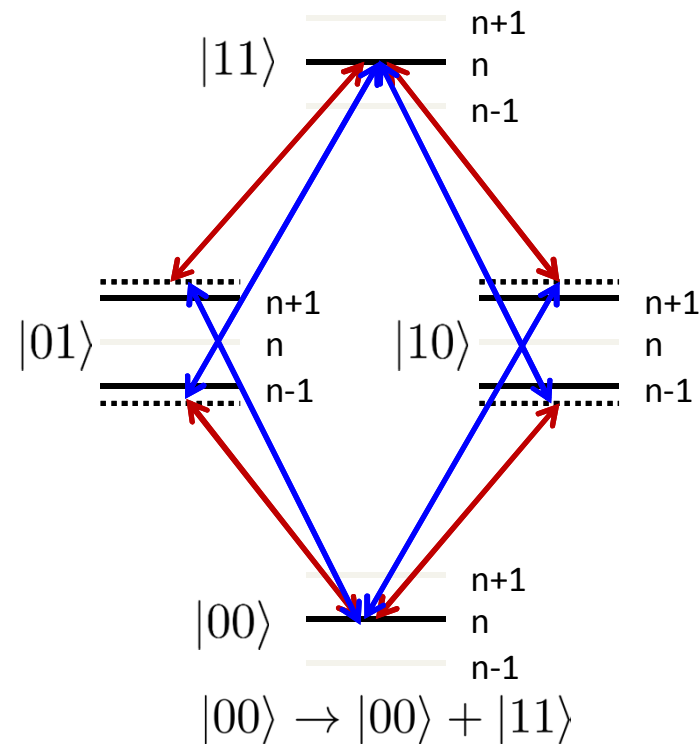
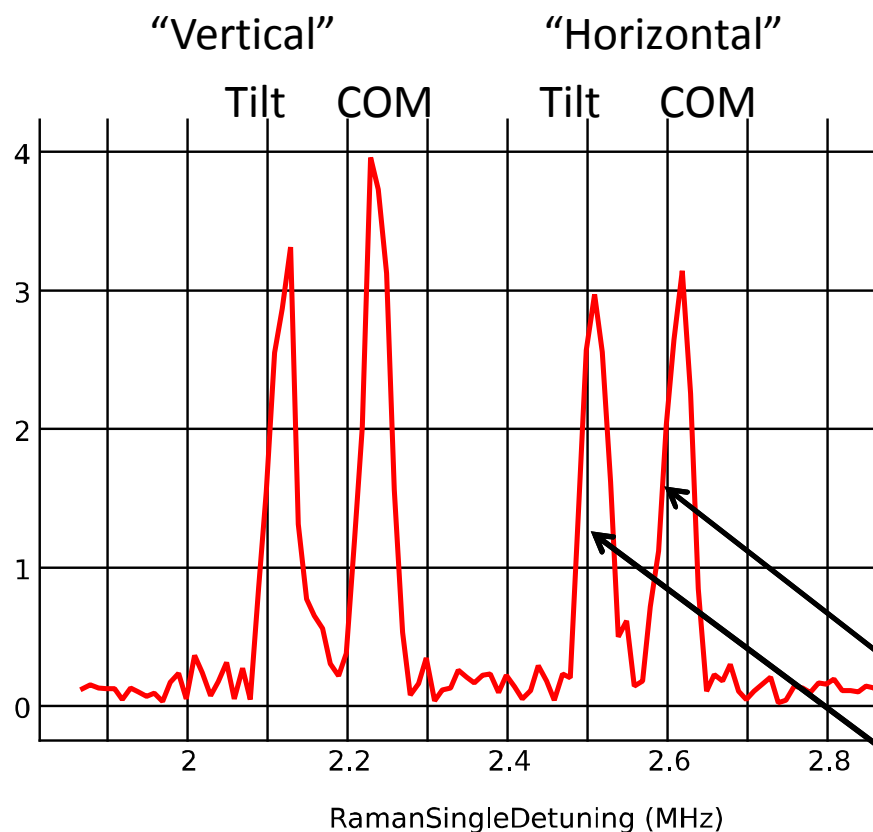
95% confidence intervals

Gate	Compensated identity		Wait identity	
	Process Infidelity	$1/2 \diamond$ -Norm	Process Infidelity	$1/2 \diamond$ -Norm
G_I	$11(1) \times 10^{-4}$	$23(1) \times 10^{-4}$	$0.9(2) \times 10^{-4}$	$8.8(4) \times 10^{-4}$
G_X	$3.9(4) \times 10^{-4}$	$13(6) \times 10^{-4}$	$5.8(4) \times 10^{-4}$	$15(6) \times 10^{-4}$
G_Y	$4.1(4) \times 10^{-4}$	$8(8) \times 10^{-4}$	$5.8(4) \times 10^{-4}$	$9(11) \times 10^{-4}$

Process Infidelity $< 6.2 \times 10^{-4}$
 $1/2 \diamond$ -Norm $< 21 \times 10^{-4}$

Two-qubit gate implementation

- Mølmer-Sørensen gates [1]
- All two-qubit gates implemented using Walsh compensation pulses [2]



Heating rates

≈ 60 quanta/s

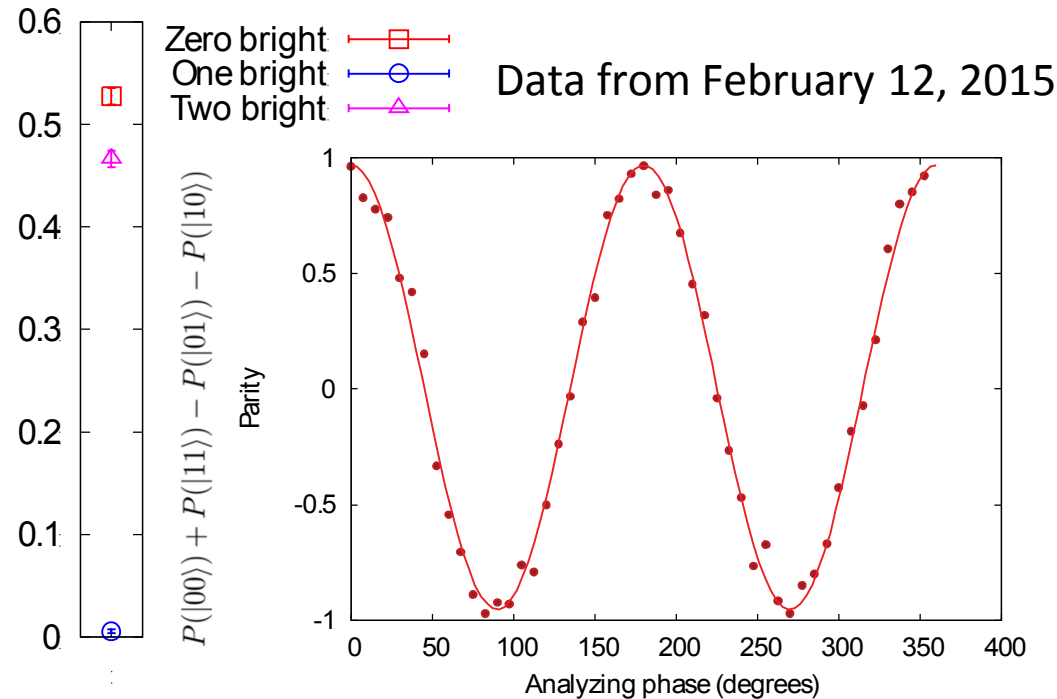
< 8 quanta/s

[1] K. Mølmer, A. Sørensen, PRL 82, 1835 (1999)

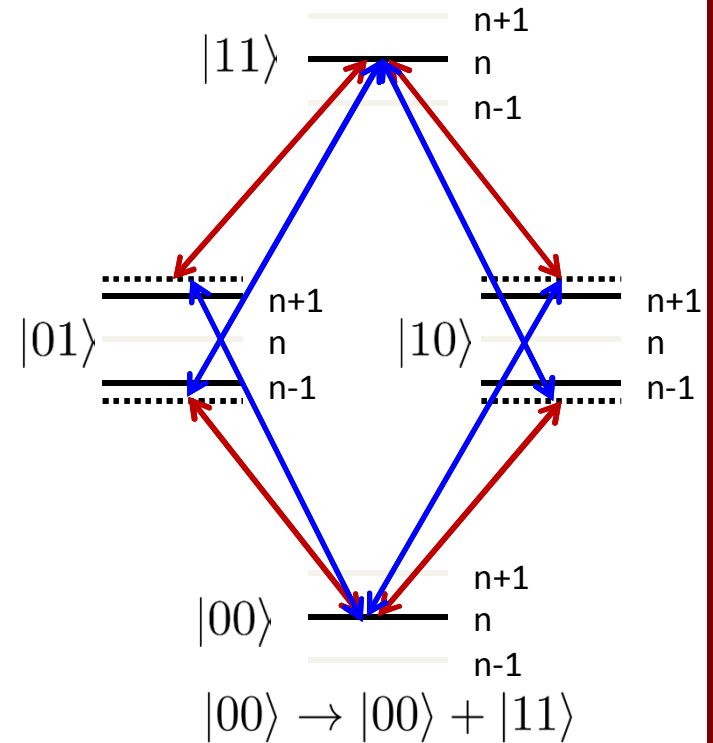
[2] D. Hayes et al. Phys. Rev. Lett. 109, 020503 (2012)

Two-qubit gate implementation

- Implemented using Walsh compensation pulses
- Optical phase sensitive



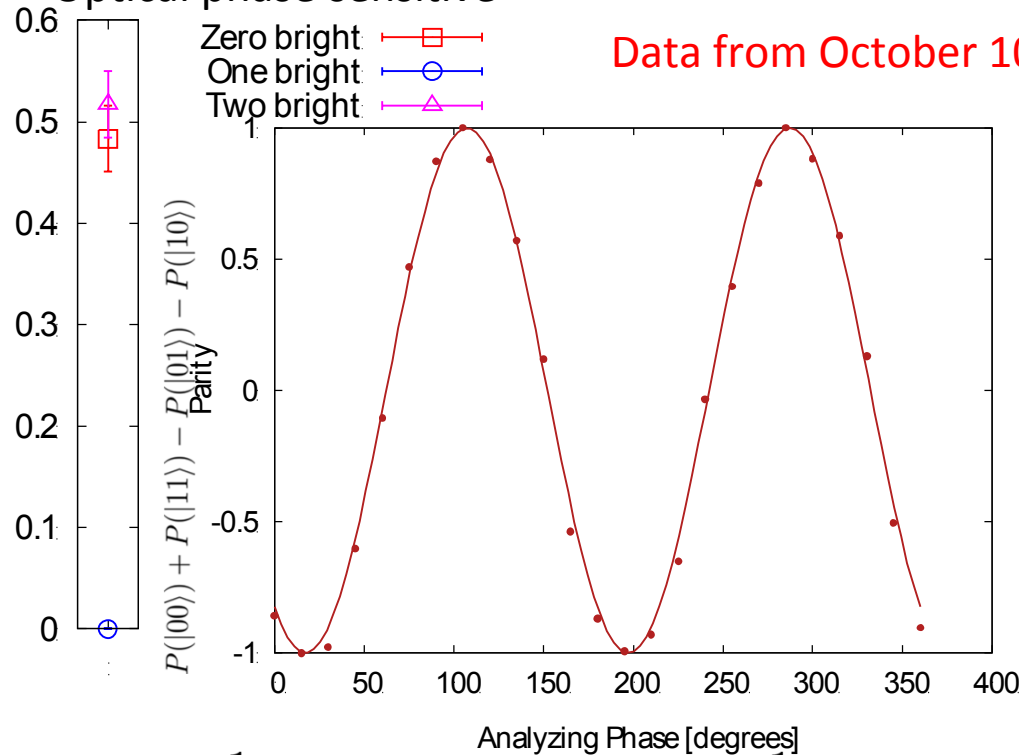
$$\mathcal{F} = \frac{1}{2}(P(|00\rangle) + P(|11\rangle)) + \frac{1}{4}c = 0.977$$



Data from February 12, 2015

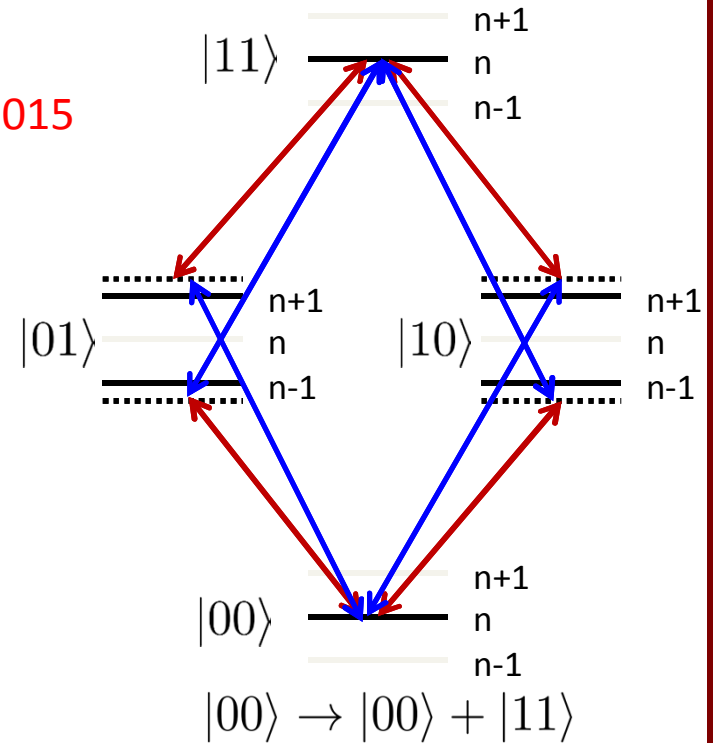
Two-qubit gate implementation

- Implemented using Walsh compensation pulses
- Optical phase sensitive



$$\mathcal{F} = \frac{1}{2}(P(|00\rangle) + P(|11\rangle)) + \frac{1}{4}c = 0.977$$

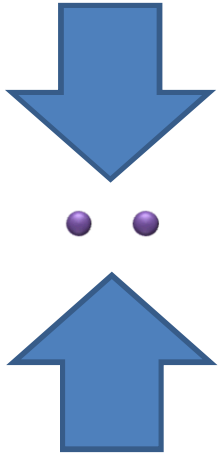
$$\mathcal{F} = \frac{1}{2}(P(|00\rangle) + P(|11\rangle)) + \frac{1}{4}c \approx 0.995$$



Data from February 12, 2015

Data from October 10, 2015

Process fidelity of two-qubit gate



Currently:

- Two ions in single trap well
- No individual addressing
- Ideally all operations are symmetric
- Only symmetric subspace of two-qubit Hilbert space is accessible

Solution:

Perform GST on symmetric subspace
of two-qubit Hilbert space

Fundamental gates:

$$G_I$$

$$G_{XX} = G_X \otimes G_X$$

$$G_{YY} = G_Y \otimes G_Y$$

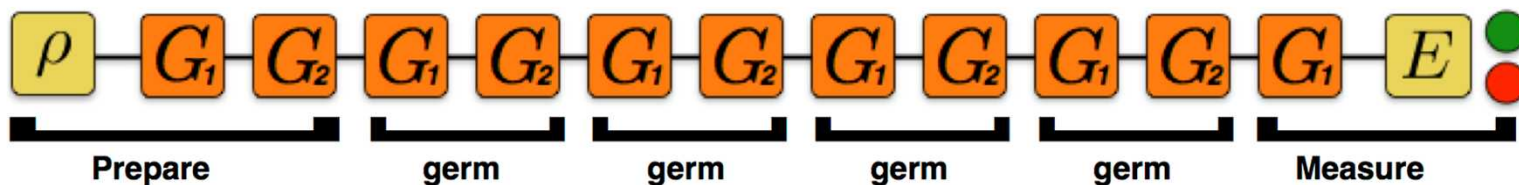
$$G_{MS}$$

9 Preparation Fiducials

12 Germs

6 Measurement Fiducials:

GST on symmetric subspace



Basic gates:

$$G_I$$

$$G_{XX} = G_X \otimes G_X$$

$$G_{YY} = G_Y \otimes G_Y$$

$$G_{MS}$$

Preparation Fiducials:

$$\{\}$$

$$G_{XX}$$

$$G_{YY}$$

$$G_{MS}$$

$$G_{XX}G_{MS}$$

$$G_{YY}G_{MS}$$

Germs:

$$G_I$$

$$G_{XX}$$

$$G_{YY}$$

$$G_{MS}$$

$$G_I G_{XX}$$

$$G_I G_{YY}$$

$$G_I G_{MS}$$

$$G_{XX} G_{YY}$$

$$G_{XX} G_{MS}$$

$$G_{YY} G_{MS}$$

$$G_I G_I G_{XX}$$

$$G_I G_I G_{YY}$$

Detection Fiducials:

$$\{\}$$

$$G_{XX}$$

$$G_{YY}$$

$$G_{MS}$$

$$G_{XX} G_{MS}$$

$$G_{YY} G_{MS}$$

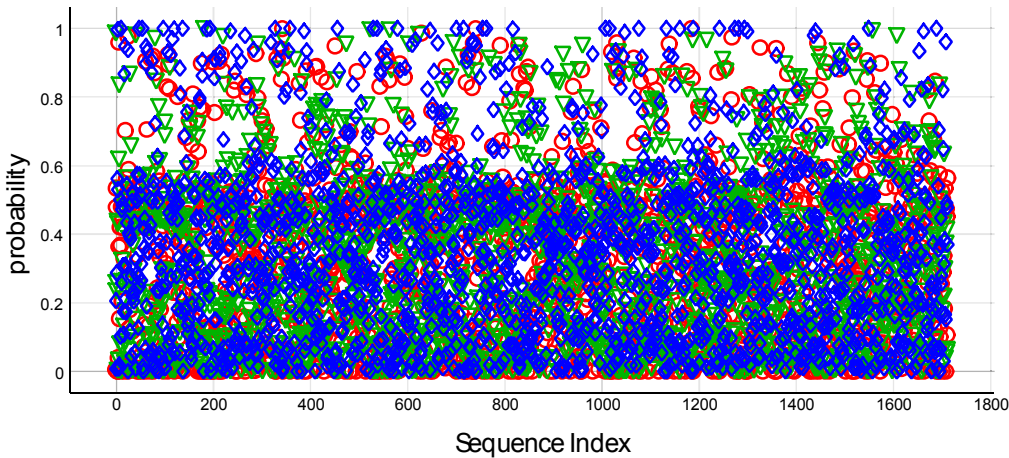
$$G_{XX}^3$$

$$G_{YY}^3$$

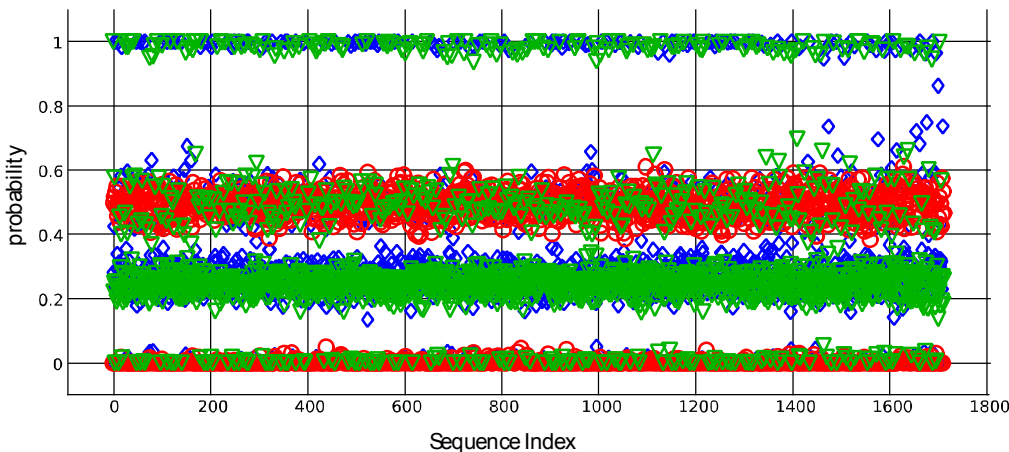
$$G_{YY}^2 G_{MS}$$

Two qubit GST raw data

GST; poor gate performance



GST; good gate performance



Zero ions bright
One ion bright
Two ions bright

Two qubit gate characterization

Gate	Process infidelity	$\frac{1}{2}$ Diamond norm
G_I	$1.6 \times 10^{-3} \pm 1.6 \times 10^{-3}$	$28 \times 10^{-3} \pm 7 \times 10^{-3}$
G_{XX}	$0.4 \times 10^{-3} \pm 1.0 \times 10^{-3}$	$27 \times 10^{-3} \pm 5 \times 10^{-3}$
G_{YY}	$0.1 \times 10^{-3} \pm 0.9 \times 10^{-3}$	$26 \times 10^{-3} \pm 4 \times 10^{-3}$
G_{MS}	$4.2 \times 10^{-3} \pm 0.6 \times 10^{-3}$	$38 \times 10^{-3} \pm 5 \times 10^{-3}$

95% confidence intervals

Process fidelity of two-qubit Mølmer-Sørensen gate > 99.5%

The best characterized two qubit gate

By the way: It's in a scalable surface trap

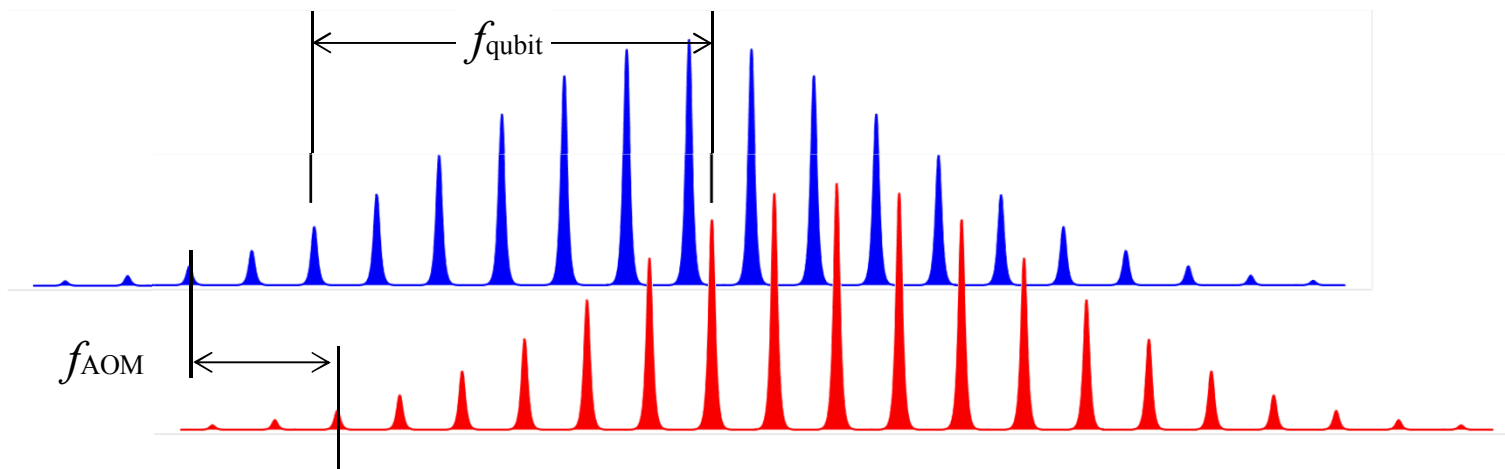
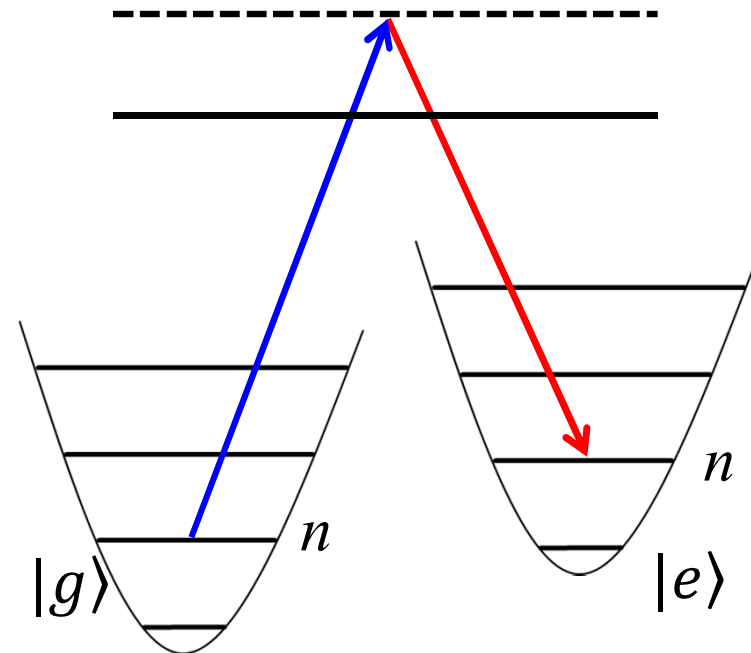
Sandia microfabricated surface traps are ready for your high fidelity operations

Demonstrated:

- Long lifetime, observed ion > 100h
- High fidelity microwave single qubit gates
Process infidelity $7.2(7) \times 10^{-5}$
below fault tolerance threshold $1/2 \|\cdot\|_{\diamond} = 8(1) \times 10^{-5}$
- High fidelity Raman laser single qubit gates
Process infidelity 1.6×10^{-4} $1/2 \|\cdot\|_{\diamond} = 5.3(2) \times 10^{-4}$
- High fidelity two qubit gates
Process infidelity $4.2(6) \times 10^{-3}$ $1/2 \|\cdot\|_{\diamond} = 38(5) \times 10^{-3}$

*Peter Maunz, Robin Blume-Kohout, M. G. Blain, C. Clark,
S. Clark, K. Fortier, R. Haltli, E. Heller, A. Hollowell, D. Lobser,
J. Mizrahi, E. Nielsen, P. Resnick, J. Rembetski, K. Rudinger,
J. D. Sterk, D. L. Stick, C. Tigges, J. Van Der Wall.*



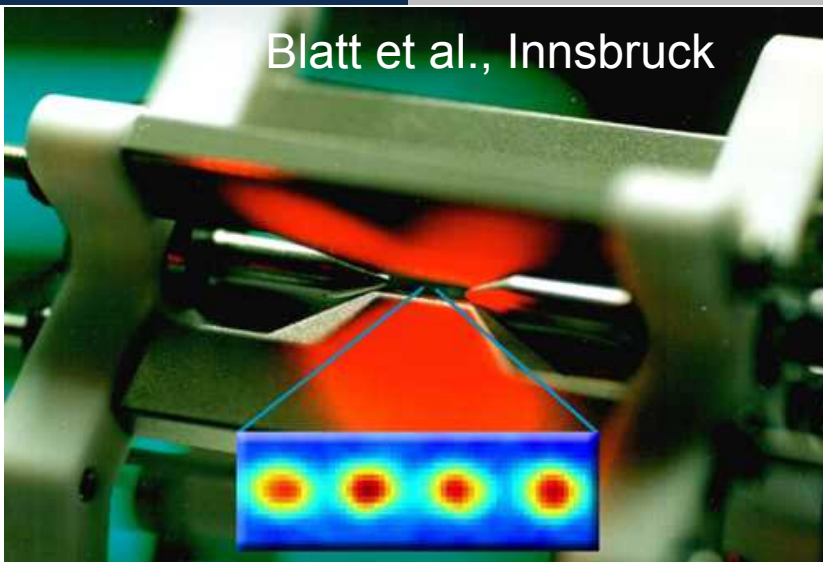




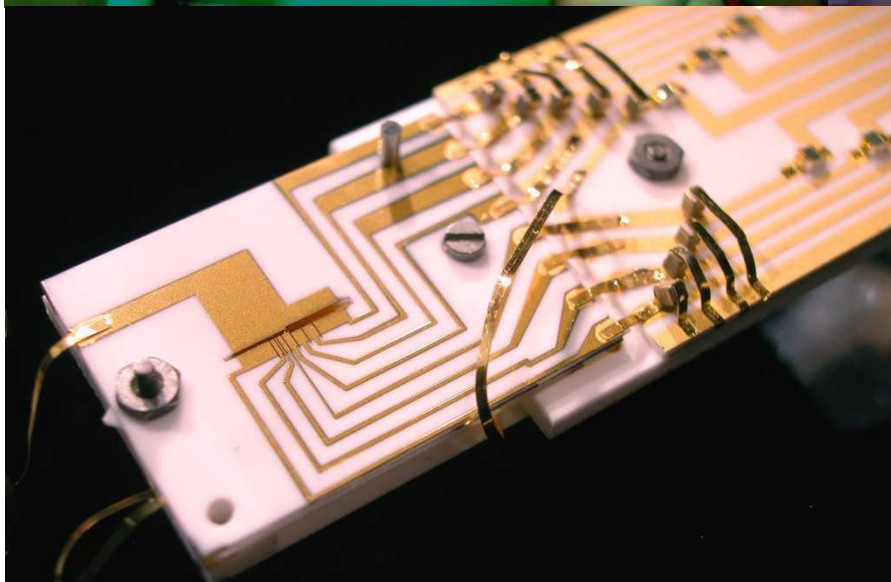
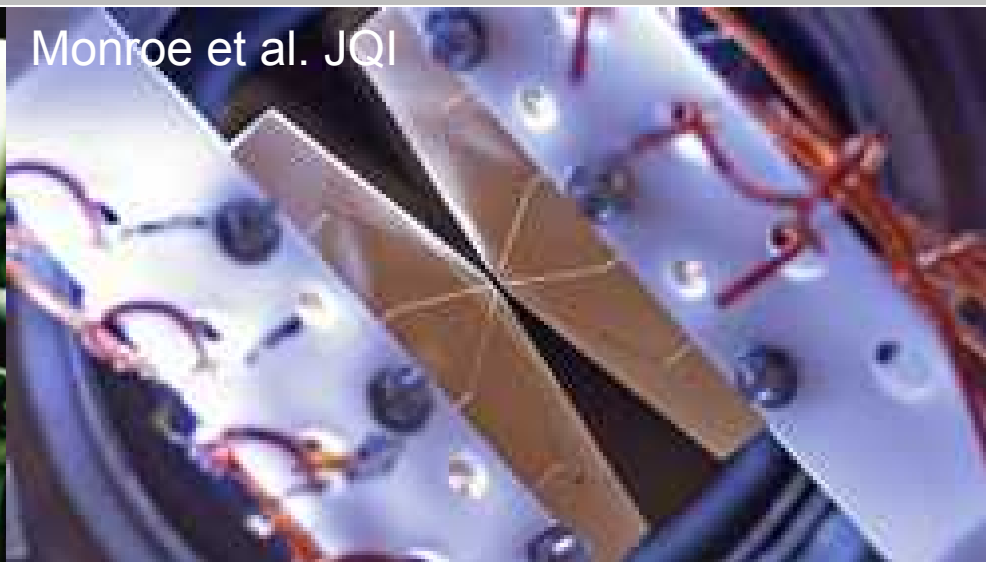
Sandia
National
Laboratories

Towards scalable ion traps

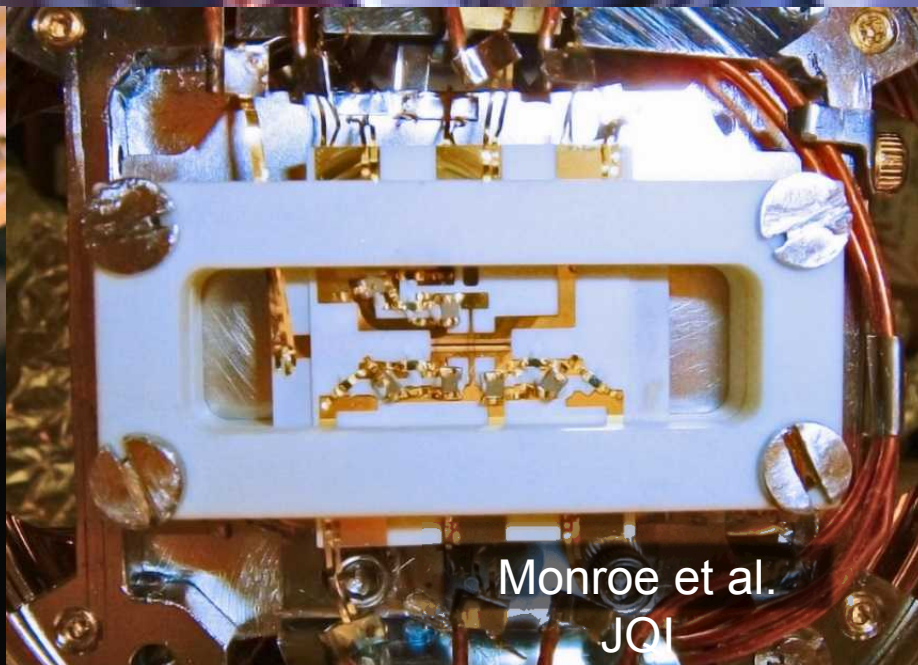
Blatt et al., Innsbruck



Monroe et al. JQI

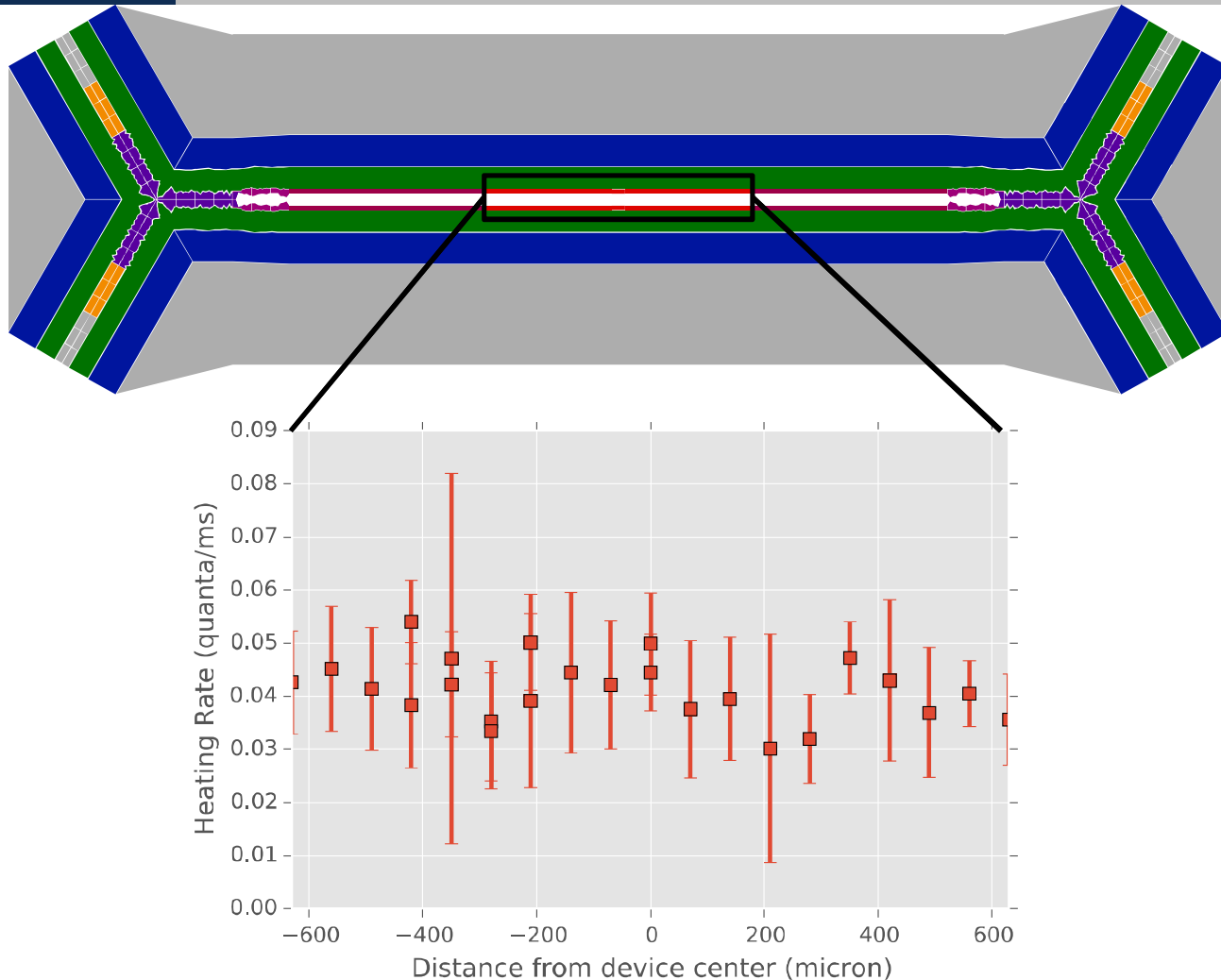


Wineland et al. NIST Boulder



Monroe et al.
JQI

Heating rate Q-section



Heating rate 40q/s on average, $^{171}\text{Yb}^+$, Trap frequency 2.8 MHz, r.f. 50 MHz

Heating rate in HOA-2 is low and uniform along the length of the quantum section

GST *debugging of the setup*

GST characterizes the implemented processes and helps identify problems
 $X_{\pi/2}$ and $Y_{\pi/2}$ gates implemented using BB1 pulse sequence

4/17: Markovianity violation

- Improve passive stability
- Add drift control of π -times

12/2: Improved X and Y gates, identity is worst

- Decoupled identity using $X_{\pi} W_{1.25\pi} - X_{\pi} W_{1.25\pi}$
- Switched to HOA-2 trap

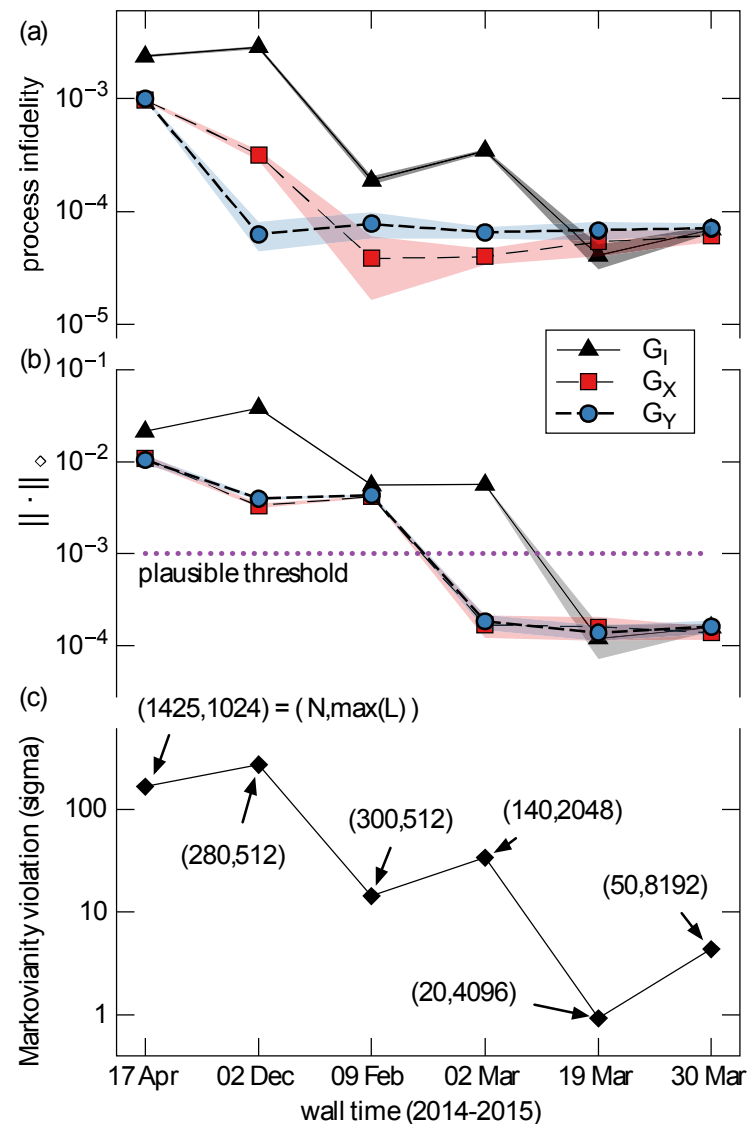
2/9: Gates improved, systematic over-rotation detected

- Improve calibration of BB1 pulses
- Drift control of qubit frequency

3/2: X and Y gates are good, identity is still worst

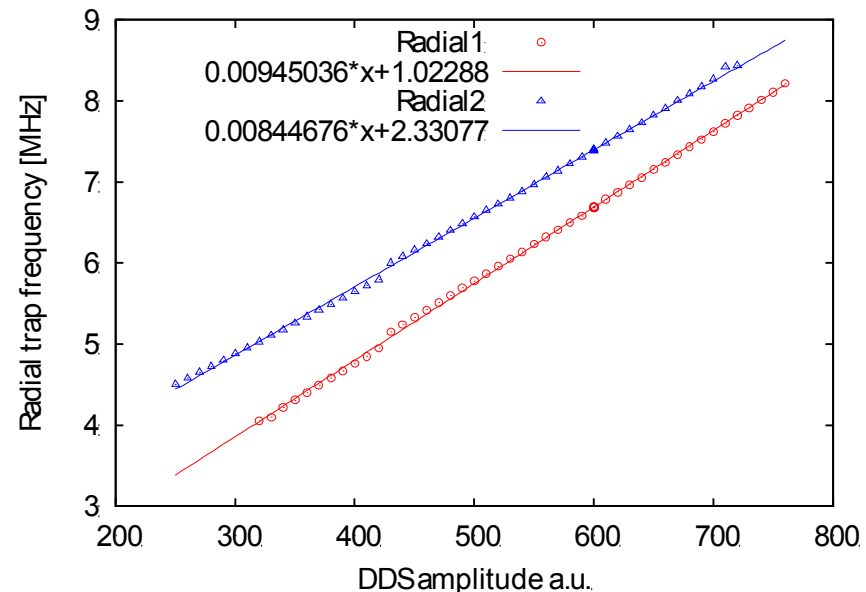
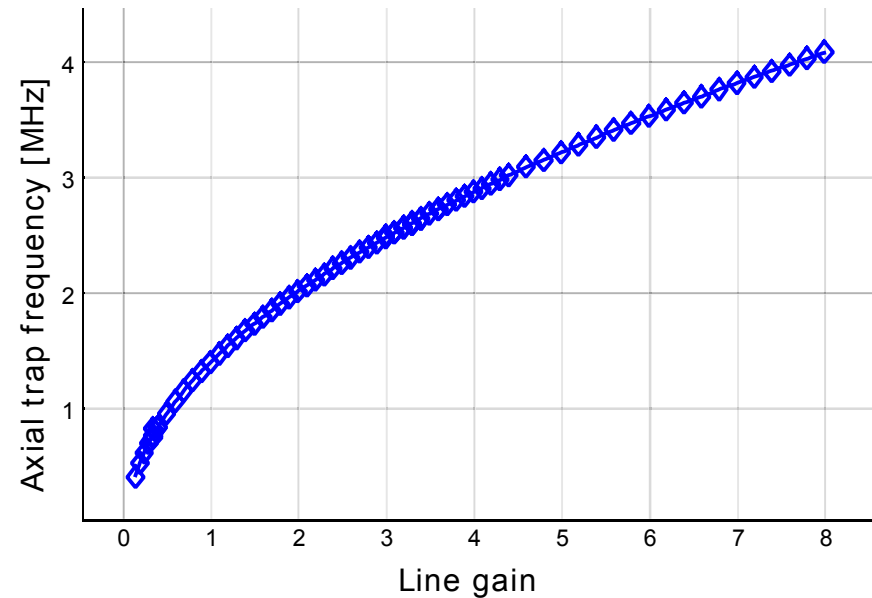
- Implement identity as $X_{\pi} Y_{\pi} X_{\pi} Y_{\pi}$

3/30: Process fidelity of all gates $\leq 6 \times 10^{-5}$



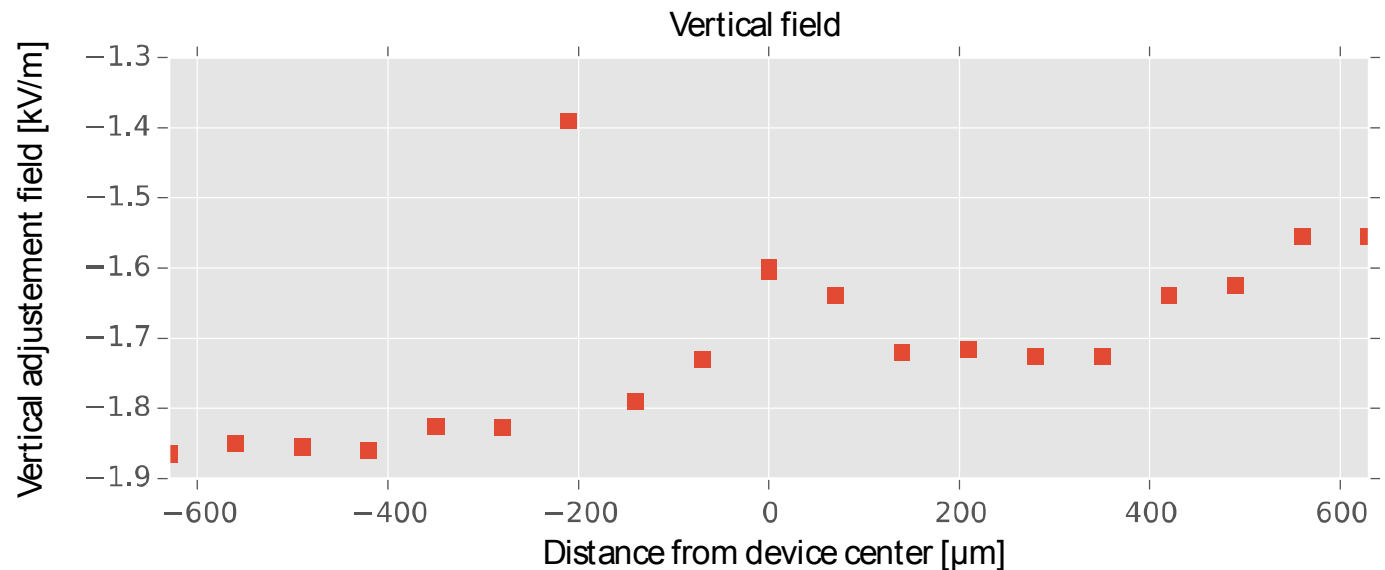
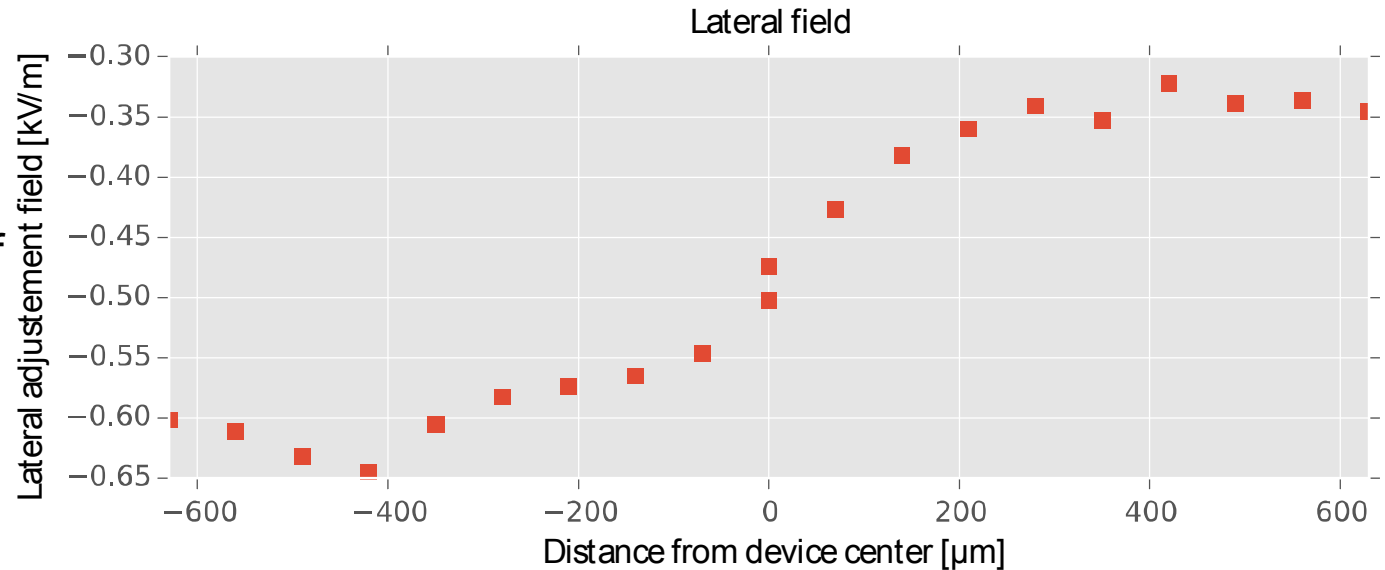
HOA-2 calcium

- Axial trap frequency as function of gain on dc control voltages
- Approximated by square root with single fit parameter
- Radial trap frequencies up to 8MHz demonstrated with rf frequency of 49MHz



Compensation Q-section

Compensation field varies slowly along linear quantum section of the trap



GST: debugging

February 9

Gate	Eigenvalues	Fixed pt	Rotn. axis	Angle	Diag. decay	Off-diag. decay
Gi	1	0.9775	0.5252	0.001699π	0.000121	0.000365
	0.9999	0.0004	-0.009			
	$0.9996e^{i0.0}$	-0.2107	0.8506			
	$0.9996e^{-i0.0}$	0.0063	-0.0244			
Gx	$1e^{i1.6}$	1	-3×10^{-6}	0.501308π	0	0.000046
	$1e^{-i1.6}$	0	-1			
	1	-0.0003	-3×10^{-5}			
	0.9999	0.0017	-0.0009			
Gy	$0.9999e^{i1.6}$	-0.9896	-0.2474	0.501366π	0.000109	0.000136
	$0.9999e^{-i1.6}$	0.0008	0.0001			
	0.9999	0.1437	0.9689			
	0.9999	-0.0016	-0.0001			

March 2

Gate	Eigenvalues	Fixed pt	Rotn. axis	Angle	Diag. decay	Off-diag. decay
Gi	$0.9993e^{i0.0}$	1	-0.0035	0.001769π	0	0.000739
	$0.9993e^{-i0.0}$	0	0.014			
	1	0.289	-0.9999			
	0.9999	0.0053	0.0006			
Gx	$0.9999e^{i1.6}$	1	-3×10^{-5}	0.500007π	0	0.000068
	$0.9999e^{-i1.6}$	0	-1			
	1	-0.0002	0.0001			
	1	0.0016	0.0006			
Gy	$0.9999e^{i1.6}$	1	0.1104	0.50001π	0	0.000084
	$0.9999e^{-i1.6}$	0	-4×10^{-5}			
	1	5.0976	0.9939			
	0.9999	0.0034	0.0005			

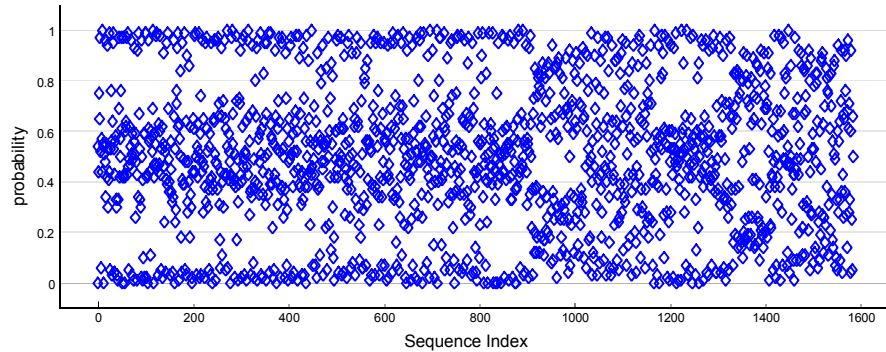
GST: *microwave single qubit gates*

Comparison of the different implementations of the identity gate:

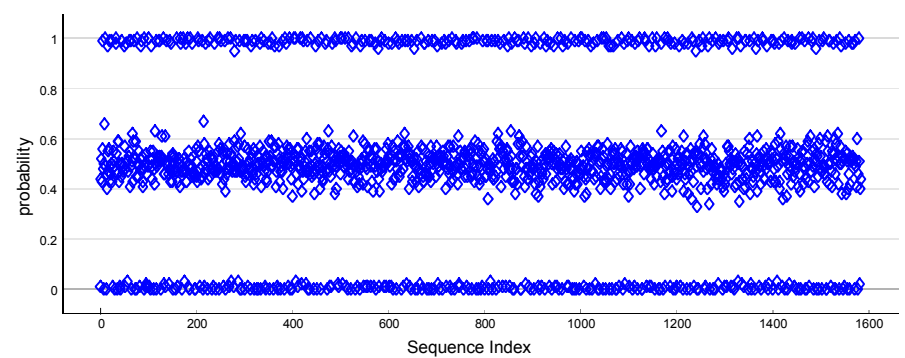
Experimental run	Process infidelity $\times 10^3$			1/2 Trace distance $\times 10^3$		
	G_I	G_X	G_Y	G_I	G_X	G_Y
wait	0.02 ± 0.5	0.31 ± 0.12	0.49 ± 0.009	0.49 ± 0.53	3.0 ± 0.12	3.9 ± 0.1
BB1 wait	1.4 ± 1.2	0.19 ± 0.18	0.06 ± 0.49	4.6 ± 0.9	3.5 ± 4	2.5 ± 0.3
BB1 XX	1.2 ± 1.4	0.1 ± 0.16	0.035 ± 0.017	7.4 ± 1.8	3.6 ± 2.2	2.4 ± 0.8
BB1 XYXY	0.06 ± 0.16	0.06 ± 0.08	0.06 ± 0.04	0.07 ± 0.17	1.3 ± 1.5	1.2 ± 0.9

GST: Raman laser qubit control

Raw data poor gates



Raw data good gates



Experimental Parameters				Infidelity $\times 10^4$		Trace Distance $\times 10^3$	
Beam Orientation	Drift Control	Compensated Gates	Gapless	Gi	max(Gx,Gy)	Gi	max(Gx,Gy)
\Rightarrow				0.16	11	1.3	7.1
\Rightarrow	✓			0.14	7.3	1.3	6.6
\Rightarrow		Gi, Gx, Gy		16.2	1.7	27	3.0
\Rightarrow	✓	Gi, Gx, Gy		10.5	2.0	15	4.0
\Rightarrow	✓	Gx, Gy		0.05	1.7	1.2	4.0
\Rightarrow	✓	Gi, Gx, Gy	✓	1.28	0.5	0.49	2.6
\rightrightarrows		Gi, Gx, Gy	✓	11.1	4.1	2.3	2.7
\rightrightarrows		Gx, Gy	✓*	0.89	5.8	8.8	2.3

High intensity laser close to trap surface does NOT lead to problems

GST on symmetric subspace

Basic gates: G_I

$$G_{XX} = G_X \otimes G_X$$

$$G_{YY} = G_Y \otimes G_Y$$

$$G_{MS}$$

Preparation Fiducials:

$\{\}$

G_{XX}

G_{YY}

G_{MS}

$G_{XX}G_{MS}$

$G_{YY}G_{MS}$

Germes:

G_I

G_{XX}

G_{YY}

G_{MS}

$G_I G_{XX}$

$G_I G_{YY}$

$G_I G_{MS}$

$G_{XX}G_{YY}$

$G_{XX}G_{MS}$

$G_{YY}G_{MS}$

$G_I G_I G_{XX}$

$G_I G_I G_{YY}$

Detection Fiducials:

$\{\}$

G_{XX}

G_{YY}

G_{MS}

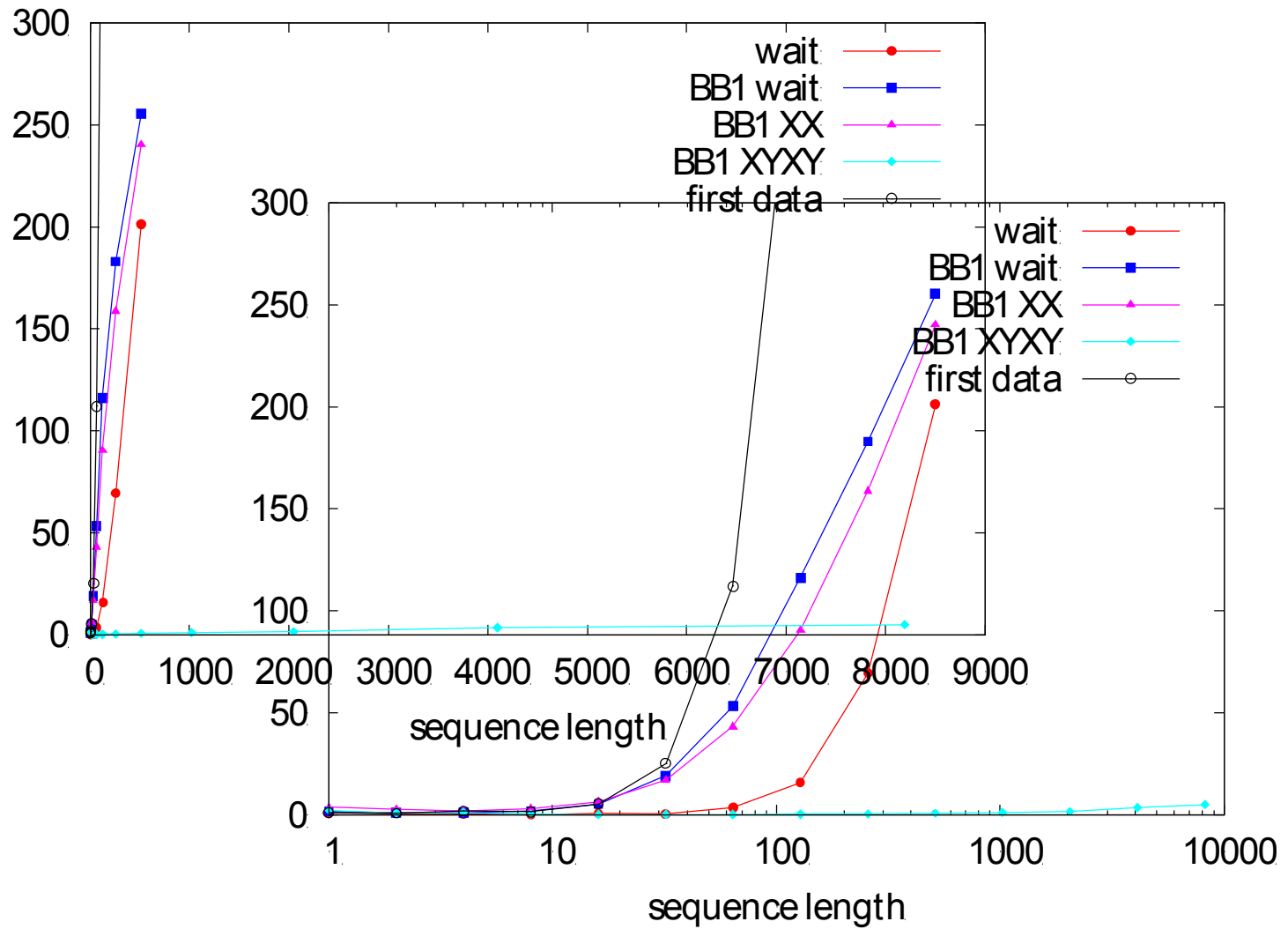
$G_{XX}G_{MS}$

$G_{YY}G_{MS}$

G_{XX}^3

G_{YY}^3

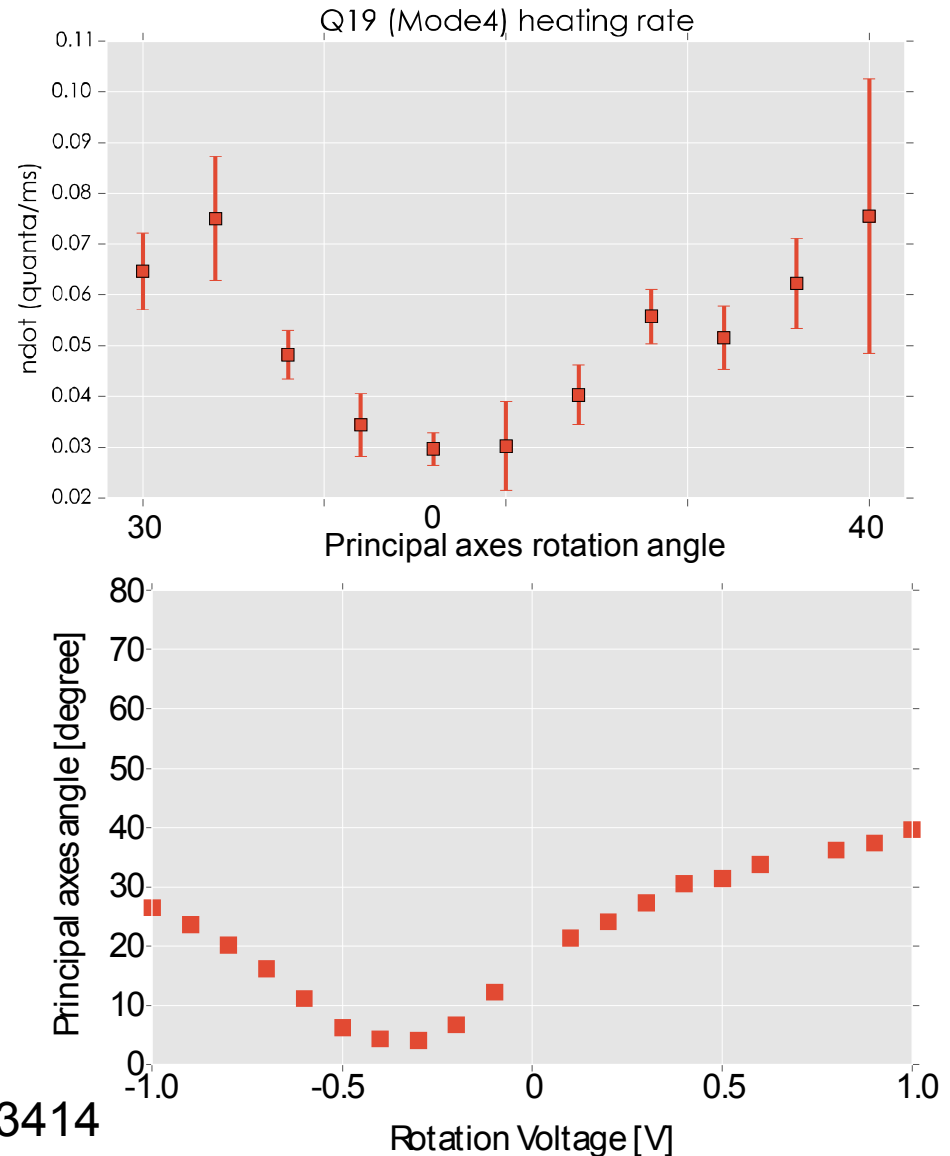
$G_{YY}^2 G_{MS}$



$^{171}\text{Yb}^+$, Trap frequency 2.8 MHz, r.f. 50 MHz

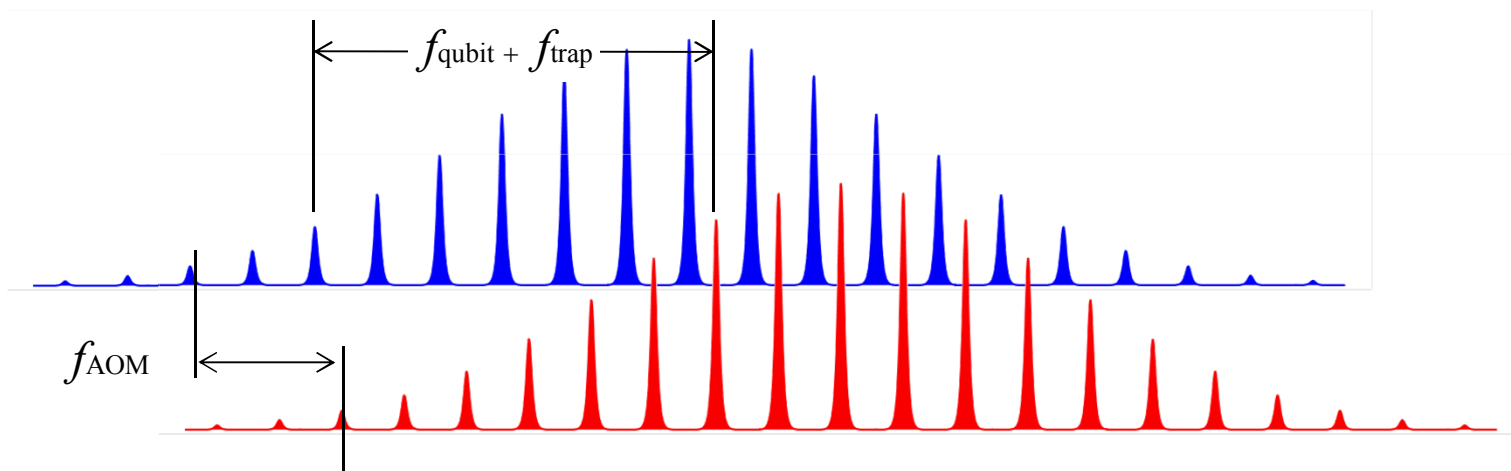
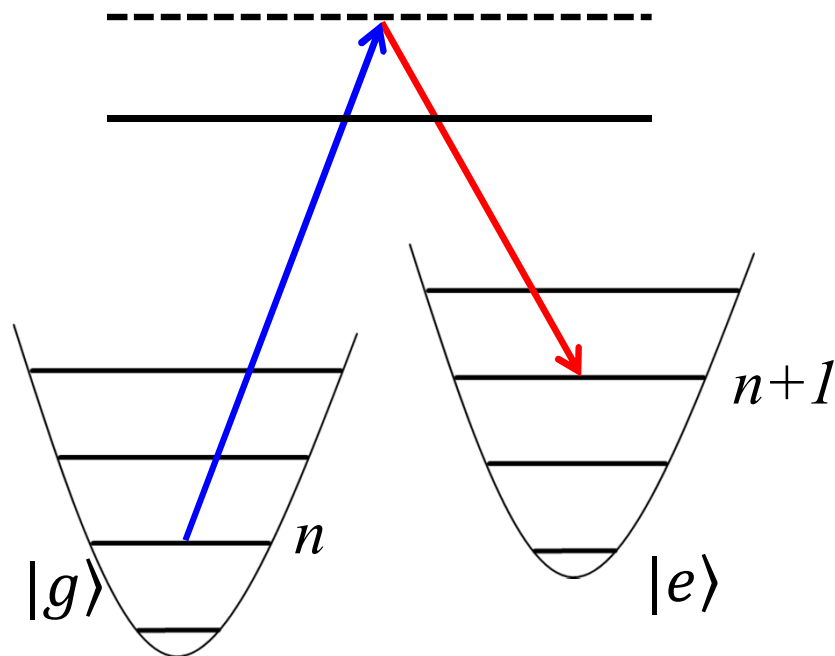
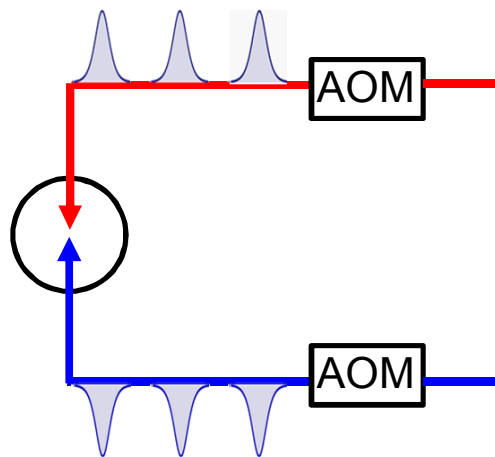
Heating rates as function of principal axes rotation

- Principal axes rotation measured by measuring π -times of Rabi flopping on cooled motional modes
- Minimal heating rates for motional mode parallel to trap surface
- Without technical noise: Vertical mode has as most
- Limited by technical noise



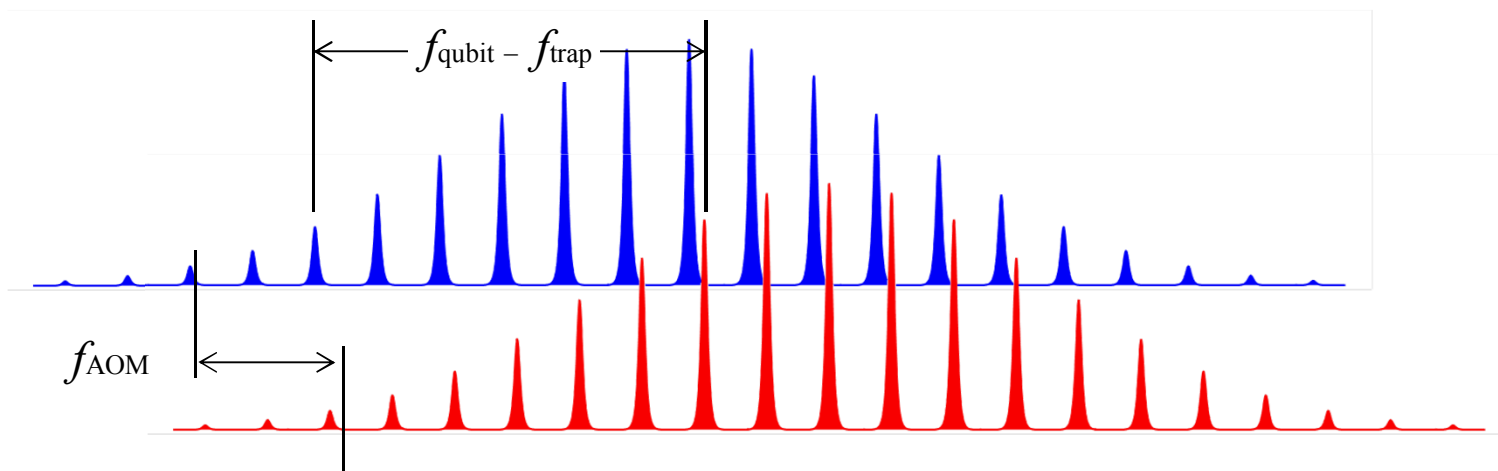
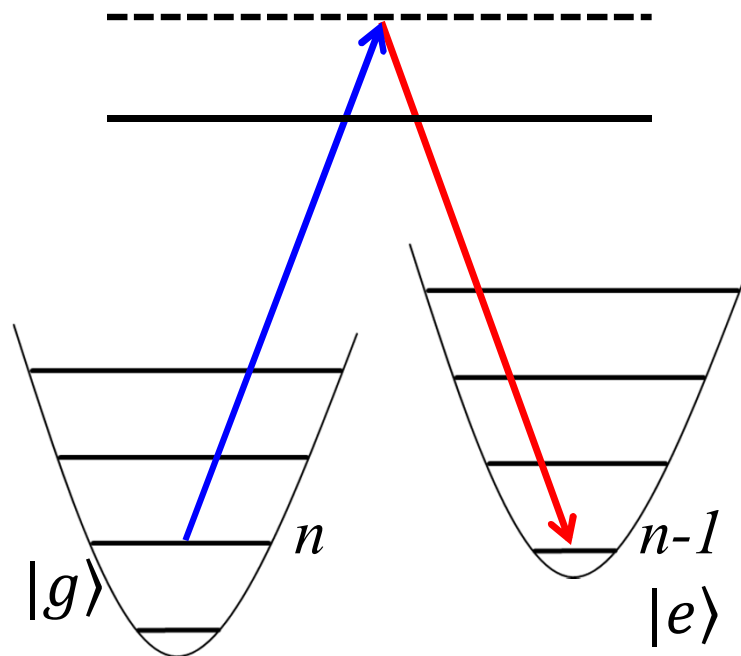
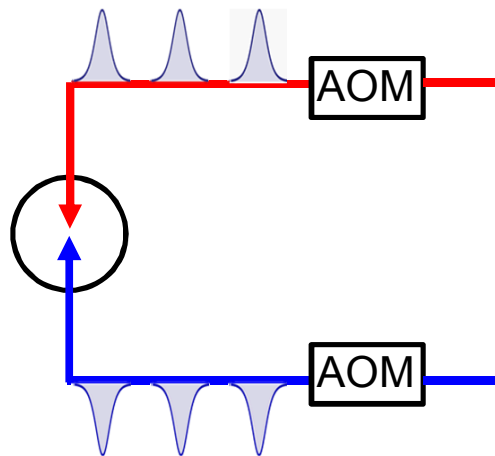


Pulsed laser Raman transitions



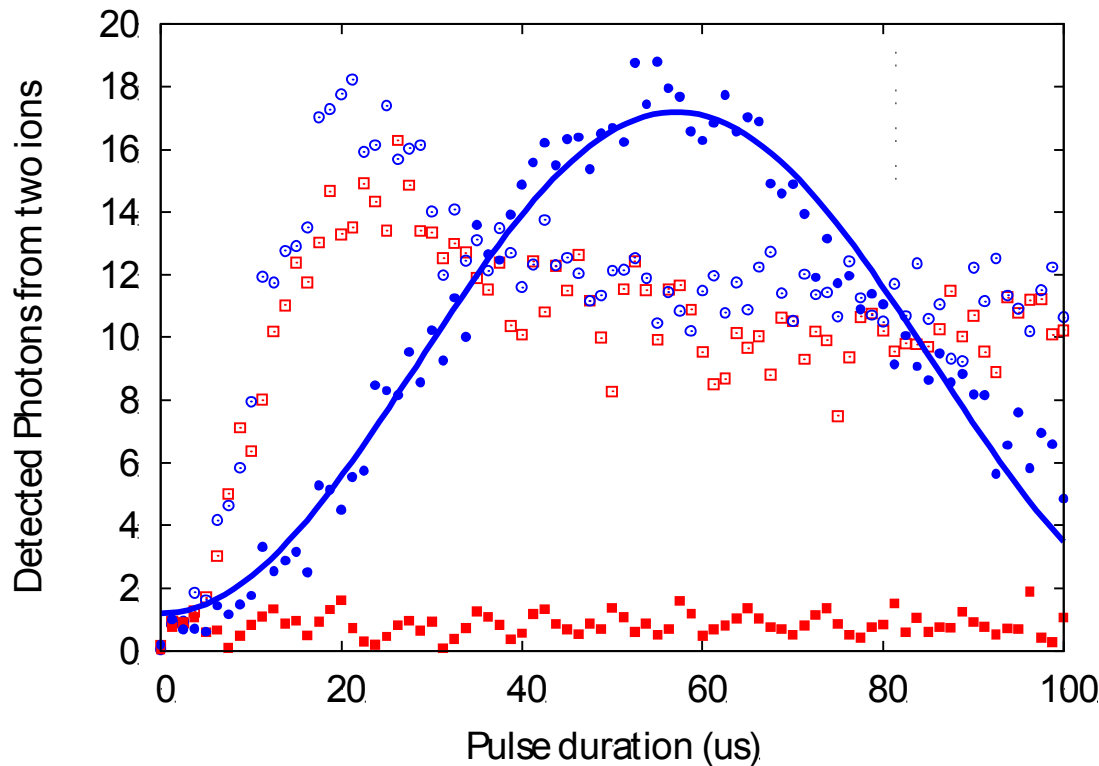


Pulsed laser Raman transitions

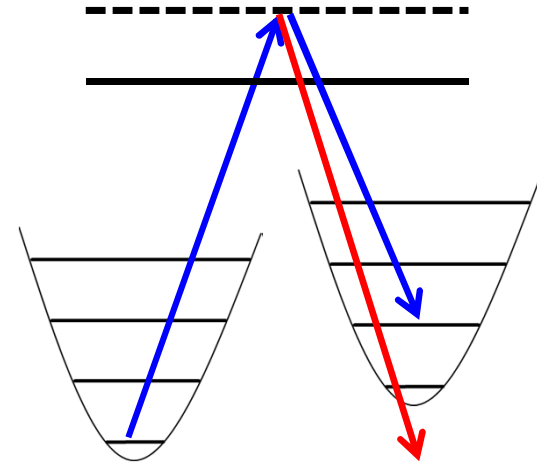


Sideband cooling

- Ground state cooling evident when red sideband cannot be driven
- Data shows ground state cooling of two ion radial tilt mode, $\bar{n} \ll 1$

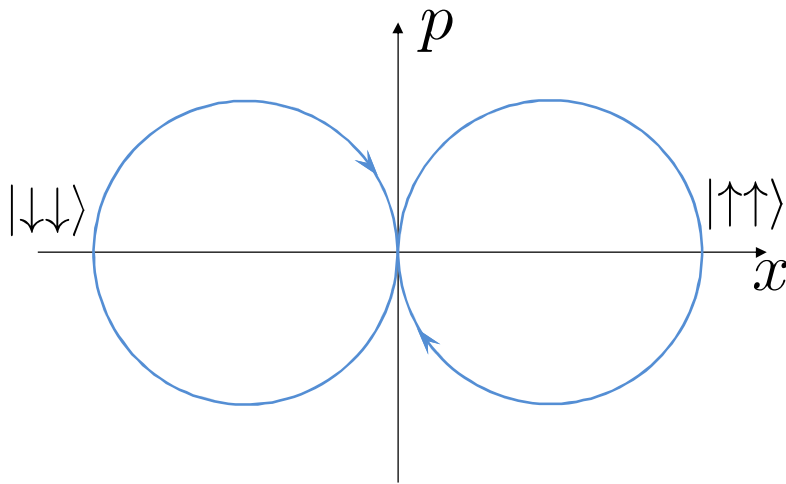


red Doppler cooled □
 blue Doppler cooled ○
 red Sideband cooled ■
 blue Sideband cooled ●



Entangling Gate

Basic idea: Use common motion of the ions
to mediate entanglement

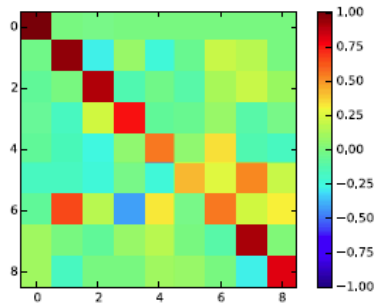


- Raman beams create *spin-dependent force*
- Force drives the ions away from and then back to their starting position
- Spin dependent phase remains

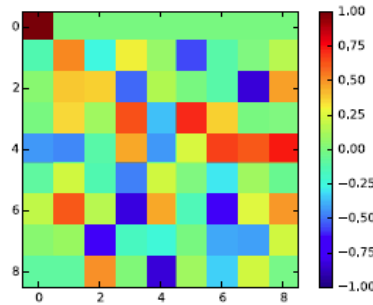
- [1] K. Mølmer, A. Sørensen, PRL 82, 1835 (1999)
- [2] A. Sørensen, K. Mølmer, PRL 82, 1971 (1999)
- [3] A. Sørensen, K. Mølmer, PRA 62, 022311 (2000)

Two-qubit gate tomography

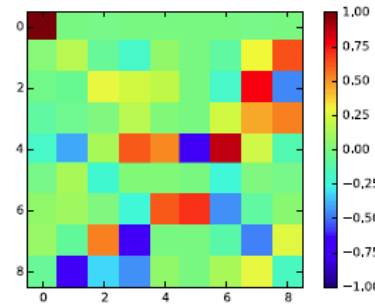
G_i (LGST)



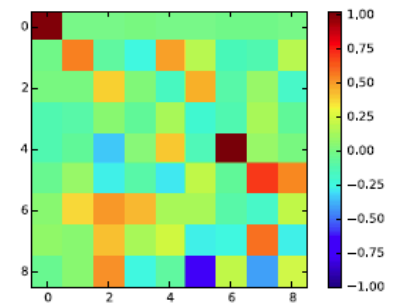
G_{xx} (LGST)



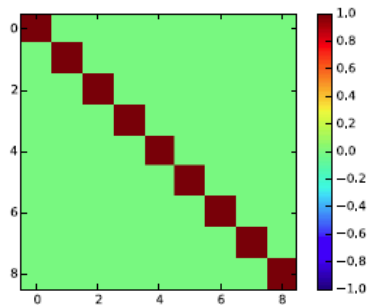
G_{yy} (LGST)



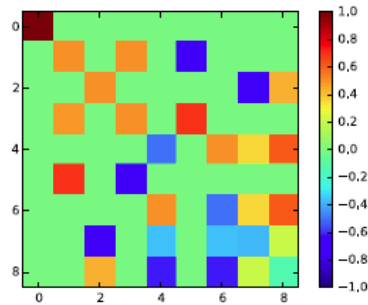
G_{M-S} (LGST)



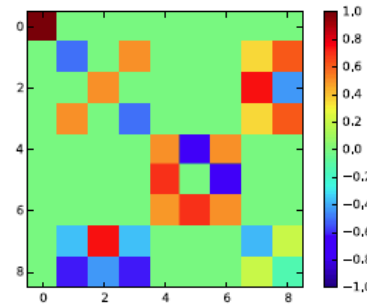
G_i (target)



G_{xx} (target)



G_{yy} (target)



G_{M-S} (target)

